

SBOS421D - MARCH 2008 - REVISED MARCH 2010

# FULLY-INTEGRATED, 8-CHANNEL ANALOG FRONT-END FOR ULTRASOUND 0.85nV/\Hz, 12-Bit, 50MSPS, 122mW/Channel

Check for Samples: AFE5805

# FEATURES

- 8-Channel Complete Analog Front-End:
  - LNA, VCA, PGA, LPF, and ADC
- Ultra-Low, Full-Channel Noise:
  - 0.85nV/√Hz (TGC)
  - 1.1nV/√Hz (CW)
- Low Power:
  - 122mW/Channel (40MSPS)
  - 74mW/Channel (CW Mode)
- Low-Noise Pre-Amp (LNA):
  - 0.75nV/√Hz
  - 20dB Fixed Gain
  - 250mV<sub>PP</sub> Linear Input Range
- Variable-Gain Amplifier:
  - Gain Control Range: 46dB
- PGA Gain Settings: 20dB, 25dB, 27dB, 30dB
- Low-Pass Filter:
  - Selectable BW: 10MHz, 15MHz
  - 2nd-Order
- Gain Error: ±0.5dB
- Channel Matching: ±0.25dB
- Distortion, HD2: –65dBFS at 5MHz
- Clamping Control
- Fast Overload Recovery: Two Clock Cycles
- 12-Bit Analog-to-Digital Converter:
  - 10MSPS to 50MSPS
  - 69.5dB SNR at 10MHz
  - Serial LVDS Interface
- Integrated CW Switch Matrix
- 15mm × 9mm, 135-BGA Package:
  - Pb-Free (RoHS-Compliant) and Green

# **APPLICATIONS**

- Medical Imaging, Ultrasound
  - Portable Systems

# DESCRIPTION

The AFE5805 is a complete analog front-end device specifically designed for ultrasound systems that require low power and small size.

The AFE5805 consists of eight channels, including a low-noise amplifier (LNA), voltage-controlled attenuator (VCA), programmable gain amplifier (PGA), low-pass filter (LPF), and a 12-bit analog-to-digital converter (ADC) with low voltage differential signaling (LVDS) data outputs.

The LNA gain is set for 20dB gain, and has excellent noise and signal handling capabilities, including fast overload recovery. VCA gain can vary over a 46dB range with a 0V to 1.2V control voltage common to all channels of the AFE5805.

The PGA can be programmed for gains of 20dB, 25dB, 27dB, and 30dB. The internal low-pass filter can also be programmed to 10MHz or 15MHz.

The LVDS outputs of the ADC reduce the number of interface lines to an ASIC or FPGA, thereby enabling the high system integration densities desired for portable systems. The ADC can either be operated with internal or external references. The ADC also features a signal-to-noise ratio (SNR) enhancement mode that can be useful at high gains.

The AFE5805 is available in a 15mm  $\times$  9mm, 135-ball BGA package that is Pb-free (RoHS-compliant) and green. It is specified for operation from 0°C to +70°C.



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### PACKAGING/ORDERING INFORMATION<sup>(1)</sup> <sup>(2)</sup> OPERATING PACKAGE TEMPERATURE ORDERING TRANSPORT DESIGNATOR PRODUCT PACKAGE-LEAD RANGE NUMBER MEDIA, QUANTITY ECO STATUS AFE5805ZCFR Tape and Reel, 1000 μFBGA-135 ZCF 0°C to +70°C AFE5805ZCFT Tape and Reel, 250 AFE5805 Pb-Free, Green AFE5805ZCF Tray, 160

(1) For the most current package and ordering information see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

(2) These packages conform to Lead (Pb)-free and green manufacturing specifications. Additional details including specific material content can be accessed at www.ti.com/leadfree.

GREEN: TI defines Green to mean Lead (Pb)-Free and in addition, uses less package materials that do not contain halogens, including bromine (Br), or antimony (Sb) above 0.1% of total product weight. N/A: Not yet available Lead (Pb)-Free; for estimated conversion dates, go to www.ti.com/leadfree. Pb-FREE: TI defines Lead (Pb)-Free to mean RoHS compatible, including a lead concentration that does not exceed 0.1% of total product weight, and, if designed to be soldered, suitable for use in specified lead-free soldering processes.

#### **ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>**

Over operating free-air temperature range, unless otherwise noted.

|                                      |                         | AFE5805                              | UNIT |
|--------------------------------------|-------------------------|--------------------------------------|------|
| Supply voltage range, A              | VDD1                    | -0.3 to +3.9                         | V    |
| Supply voltage range, A              | VDD2                    | -0.3 to +3.9                         | V    |
| Supply voltage range, AVDD_5V        |                         | -0.3 to +6                           | V    |
| Supply voltage range, DVDD           |                         | -0.3 to +3.9                         | V    |
| Supply voltage range, LVDD           |                         | -0.3 to +2.2                         | V    |
| Voltage between AVSS1 and LVSS       |                         | -0.3 to +0.3                         | V    |
| Voltage at analog inputs             |                         | -0.3 to minimum [3.6, (AVDD2 + 0.3)] | V    |
| External voltage applied to REFT-pin |                         | -0.3 to +3                           | V    |
| External voltage applied             | to REFB-pin             | -0.3 to +2                           | V    |
| Voltage at digital inputs            |                         | -0.3 to minimum [3.9, (AVDD2 + 0.3)] | V    |
| Peak solder temperature              | (2)                     | +260                                 | °C   |
| Maximum junction tempe               | erature, T <sub>J</sub> | +125                                 | °C   |
| Storage temperature ran              | ge                      | -55 to +150                          | °C   |
| Operating temperature ra             | ange                    | 0 to +70                             | °C   |
|                                      | HBM                     | 2000                                 | V    |
| ESD ratings                          | CDM                     | 1000                                 | V    |
|                                      | MM                      | 100                                  | V    |

(1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not supported.

(2) Device complies with JSTD-020D.



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# **ELECTRICAL CHARACTERISTICS**

AVDD\_5V = 5.0V, AVDD1 = AVDD2 = DVDD = 3.3V, LVDD = 1.8V, single-ended input into LNA, ac-coupled (1.0µF),  $V_{CNTL}$  = 1.0V,  $f_{IN}$  = 5MHz, Clock = 40MSPS, 50% duty cycle, internal reference mode, ISET = 56k $\Omega$ , LVDS buffer setting = 3.5mA, at ambient temperature  $T_A = +25^{\circ}C$ , unless otherwise noted.

| PARAMETER                           |                      | TEST CONDITIONS                                    | MIN  | ТҮР            | MAX  | UNIT             |  |
|-------------------------------------|----------------------|--|------|----------------|------|------------------|--|
| PREAMPLIFIER (LNA)                  |                      |  |      |                |      |                  |  |
| Gain                                | А                    | SE-input to differential output                    |      | 20             |      | dB               |  |
| Input voltage                       | V <sub>IN</sub>      | Linear operation (HD2 $\leq$ -40dB)                |      | 250            |      | mV <sub>PP</sub> |  |
| input voltage                       |                      | Limited by internal diodes                         |      | 600            |      | mV <sub>PP</sub> |  |
| Input voltage noise (TGC)           | e <sub>n</sub> (RTI) | $R_{S} = 0\Omega$ , f = 1MHz                       |      | 0.75           |      | nV/√Hz           |  |
| Input current noise                 | I <sub>n</sub> (RTI) |  |      | 3              |      | pA/√Hz           |  |
| Common-mode voltage, input          | V <sub>CMI</sub>     | Internally generated                               |      | 2.4            |      | V                |  |
| Bandwidth                           | BW                   | Small-signal, –3dB                                 |      | 70             |      | MHz              |  |
| Input resistance <sup>(1)</sup>     |                      | At f = 4MHz  |      | 8              |      | kΩ               |  |
| Input capacitance <sup>(1)</sup>    |                      | Includes internal ESD and clamping diodes          |      | 16             |      | pF               |  |
| FULL-SIGNAL CHANNEL (LNA            | +VCA+LPF             | +ADC)  |      |                |      |                  |  |
| Input voltage noise (TGC)           | en                   | $R_S = 0\Omega$ , f = 2MHz, PGA = 30dB             |      | 0.85           |      | nV/√Hz           |  |
|                                     |                      | $R_{S} = 0\Omega$ , f = 2MHz, PGA = 20dB           |      | 1.08           |      | nV/√Hz           |  |
| Noise figure                        | NF                   | $R_S = 200\Omega$ , f = 5MHz                       |      | 1.5            |      | dB               |  |
| Low-pass filter bandwidth           | LPF                  | at –3dB, selectable through SPI                    |      | 10, 15         |      | MHz              |  |
| Bandwidth tolerance                 |                      |  |      | ±10            |      | %                |  |
| High-pass filter                    | HPF                  | (First-order, due to internal ac-coupling)         |      | 200            |      | kHz              |  |
| Group delay variation               |                      |  |      | ±3             |      | ns               |  |
| Overload recovery                   |                      | ≤ 6dB overload to within 1%                        |      | 2              |      | Clock Cycles     |  |
| ACCURACY                            |                      |  |      |                |      | - <b>I</b>       |  |
| Gain (PGA)                          |                      | Selectable through SPI                             |      | 20, 25, 27, 30 |      | dB               |  |
| Total gain, max <sup>(2)</sup>      |                      | LNA + PGA gain, V <sub>CNTL</sub> = 1.2V           | 48   | 49.5           | 51   | dB               |  |
| Gain range                          |                      | $V_{CNTL} = 0V$ to 1.2V                            |      | 46             |      | dB               |  |
|                                     |                      | $V_{CNTL} = 0.1V$ to 1.0V                          |      | 40             |      | dB               |  |
| Gain error, absolute <sup>(3)</sup> |                      | 0V < V <sub>CNTL</sub> < 0.1V                      |      | ±0.5           |      | dB               |  |
|                                     |                      | 0.1V < V <sub>CNTL</sub> < 1.0V                    | -1.5 | ±0.5           | +1.5 | dB               |  |
|                                     |                      | 1.0V < V <sub>CNTL</sub> < 1.2V                    |      | ±0.5           |      | dB               |  |
| Gain matching                       |                      | Channel-to-channel                                 | -0.5 | ±0.25          | +0.5 | dB               |  |
| Offset error                        |                      | $V_{CNTL} = 1.0V, PGA = 30dB$                      | -39  |                | +39  | LSB              |  |
| Offset error drift (tempco)         |                      |  |      | ±5             |      | ppm/°C           |  |
| Clamp level                         |                      | CL = 0   |      | 1.7            |      | V <sub>PP</sub>  |  |
|                                     |                      | CL = 1 (clamp disabled)                            |      | 2.8            |      | V <sub>PP</sub>  |  |
| GAIN CONTROL (VCA)                  | l                    |  |      |                |      | - <b>k</b>       |  |
| Input voltage range                 | V <sub>CNTL</sub>    | Gain range = 46dB                                  |      | 0 to 1.2       |      | V                |  |
| Gain slope                          |                      | $V_{CNTL} = 0.1V$ to 1.0V                          |      | 44.4           |      | dB/V             |  |
| Input resistance                    |                      |  |      | 25             |      | kΩ               |  |
| Response time                       |                      | V <sub>CNTL</sub> = 0V to 1.2V step; to 90% signal |      | 0.5            |      | μs               |  |
| DYNAMIC PERFORMANCE                 |                      |  |      | - ı — I —      |      |                  |  |
| Signal-to-noise ratio               | SNR                  | f <sub>IN</sub> = 2MHz; -1dBFS, PGA = 30dB         |      | 59.8           |      | dBFS             |  |
|                                     |                      | f <sub>IN</sub> = 5MHz; -1dBFS, PGA = 30dB         |      | 59.6           |      | dBFS             |  |
|                                     |                      | f <sub>IN</sub> = 10MHz; –1dBFS, PGA = 30dB        |      | 58.8           |      | dBFS             |  |

(1) See Figure 33.

Excludes digital gain within ADC. Excludes error of internal reference. (2)

(3)

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# ELECTRICAL CHARACTERISTICS (continued)

AVDD\_5V = 5.0V, AVDD1 = AVDD2 = DVDD = 3.3V, LVDD = 1.8V, single-ended input into LNA, ac-coupled (1.0 $\mu$ F), V<sub>CNTL</sub> = 1.0V, f<sub>IN</sub> = 5MHz, Clock = 40MSPS, 50% duty cycle, internal reference mode, ISET = 56k $\Omega$ , LVDS buffer setting = 3.5mA, at ambient temperature T<sub>A</sub> = +25°C, unless otherwise noted.

|   |                    |  | AFE5805 |      |       |                  |
|---|--------------------|--|---------|------|-------|------------------|
| PARAMETER   |                    | TEST CONDITIONS  | MIN     | ТҮР  | MAX   | UNIT             |
| DYNAMIC PERFORMANCE (co   | ntinued)           |  |         |      |       |                  |
| Second-harmonic distortion                                      | HD2                | f <sub>IN</sub> = 2MHz; -1dBFS, PGA = 30dB                                 |         | -70  |       | dBFS             |
|   |                    | f <sub>IN</sub> = 5MHz; -1dBFS, PGA = 30dB                                 | -54     | -65  |       | dBFS             |
|   |                    | $f_{IN} = 5MHz; -6dBFS, PGA = 20dB$  | 61      | -69  |       | dBFS             |
| Third-harmonic distortion                                       | HD3                | $f_{IN} = 2MHz; -1dBFS, PGA = 30dB$  |         | -58  |       | dBFS             |
|   |                    | $f_{IN} = 5MHz; -1dBFS, PGA = 30dB$  | -51     | -59  |       | dBFS             |
|   |                    | $f_{IN} = 5MHz; -6dBFS, PGA = 20dB$  | -56     | -78  |       | dBFS             |
| Intermodulation distortion                                      | IMD3               | f <sub>1</sub> = 4.99MHz at –6dBFS,<br>f <sub>2</sub> = 5.01MHz at −32dBFS |         | 58.5 |       | dBc              |
| Crosstalk   |                    | $f_{IN} = 5MHz, -1dBFS, PGA = 30dB$  |         | -67  |       | dBc              |
| CW—SIGNAL CHANNELS  |                    |  |         |      |       |                  |
| Input voltage noise (CW)  | e <sub>n</sub>     | $R_{S} = 0\Omega, f = 1MHz$  |         | 1.1  |       | nV/√Hz           |
| Output noise correlation factor                                 |                    | Summing of eight channels  |         | 0.6  |       | dB               |
| Output transconductance<br>(I <sub>OUT</sub> /V <sub>IN</sub> ) |                    | At $V_{IN} = 100 m V_{PP}$   | 14      | 15.6 | 18    | mA/V             |
| Dynamic CW output current, maximum                              | I <sub>OUTAC</sub> |  |         | 2.9  |       | mA <sub>PP</sub> |
| Static CW output current (sink)                                 | I <sub>OUTDC</sub> |  |         | 0.9  |       | mA               |
| Output common-mode voltage <sup>(4)</sup>                       | VCM                |  |         | 2.5  |       | V                |
| Output impedance  |                    |  |         | 50   |       | kΩ               |
| Output capacitance  |                    |  |         | 10   |       | pF               |
| NTERNAL REFERENCE VOLT  | AGES (ADC)         |  |         |      |       |                  |
| Reference top   | VREFT              |  |         | 0.5  |       | V                |
| Reference bottom  | VREFB              |  |         | 2.5  |       | V                |
| VREFT – VREFB   |                    |  | 1.95    | 2    | 2.05  | V                |
| Common-mode voltage<br>(internal)                               | V <sub>CM</sub>    |  | 1.425   | 1.5  | 1.575 | V                |
| V <sub>CM</sub> output current                                  |                    |  |         | ±2   |       | mA               |
| EXTERNAL REFERENCE VOLT   | AGES (ADC          | ;)   |         |      |       |                  |
| Reference top   | VREFT              |  | 2.4     | 2.5  | 2.6   | V                |
| Reference bottom  | VREFB              |  | 0.4     | 0.5  | 0.6   | V                |
| VREFT – VREFB   |                    |  | 1.9     |      | 2.1   | V                |
| Switching current <sup>(5)</sup>                                |                    |  |         | 2.5  |       | mA               |

(4) CW outputs require an externally applied bias voltage of +2.5V.

(5) Current drawn by the eight ADC channels from the external reference voltages; sourcing for VREFT, sinking for VREFB.



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#### ELECTRICAL CHARACTERISTICS (continued)

AVDD\_5V = 5.0V, AVDD1 = AVDD2 = DVDD = 3.3V, LVDD = 1.8V, single-ended input into LNA, ac-coupled (1.0 $\mu$ F), V<sub>CNTL</sub> = 1.0V, f<sub>IN</sub> = 5MHz, Clock = 40MSPS, 50% duty cycle, internal reference mode, ISET = 56k $\Omega$ , LVDS buffer setting = 3.5mA, at ambient temperature T<sub>A</sub> = +25°C, unless otherwise noted.

| PARAMETER                               |                 | TEST CONDITIONS                                | MIN TYP |     | MAX  | UNIT |  |
|---|-----------------|--|---------|-----|------|------|--|
| POWER SUPPLY                            |                 |  |         |     |      |      |  |
| Supply Voltages                         |                 |  |         |     |      |      |  |
| AVDD1, AVDD2, DVDD                      |                 | Operating                                      | 3.15    | 3.3 | 3.47 | V    |  |
| AVDD_5V                                 |                 | Operating                                      | 4.75    | 5   | 5.25 | V    |  |
| LVDD                                    |                 |  | 1.7     | 1.8 | 1.9  | V    |  |
| Supply Currents                         |                 |  |         |     |      |      |  |
| IAVDD1 (ADC)                            |                 | at 40MSPS                                      |         | 99  | 110  | mA   |  |
| IAVDD2 (VCA)                            |                 | TGC mode                                       |         | 146 | 156  | mA   |  |
|   |                 | CW mode  |         | 79  | 85   | mA   |  |
| IAVDD_5V (VCA)                          |                 | TGC mode                                       |         | 8   | 10   | mA   |  |
|   |                 | CW mode  |         | 55  | 61   | mA   |  |
| IDVDD (VCA)                             |                 |  |         | 1.5 | 3.0  | mA   |  |
| ILVDD (ADC)                             |                 | At 40MSPS                                      |         | 70  | 80   | mA   |  |
| Power dissipation, total                |                 | All channels, TGC mode, no signal              |         | 980 | 1080 | mW   |  |
|   |                 | All channels, CW mode , no signal $^{\rm (6)}$ |         | 580 | 620  | mW   |  |
|   |                 | TGC mode, no clock applied, no signal          |         | 615 |      | mW   |  |
| POWER-DOWN MODES                        |                 |  |         |     |      |      |  |
| Power-down dissipation, total           |                 | Complete power-down mode                       |         | 64  | 85   | mW   |  |
| Power-down response time <sup>(7)</sup> |                 |  |         | 1.0 |      | μs   |  |
| Power-up response time <sup>(7)</sup>   |                 | PD to valid output (90% level)                 |         | 50  |      | μs   |  |
| Power-down dissipation <sup>(7)</sup>   |                 | Partial power-down mode                        |         | 233 |      | mW   |  |
| THERMAL CHARACTERISTICS                 |                 |  |         |     |      |      |  |
| Temperature range                       |                 |  | 0       |     | +70  | °C   |  |
| Thermal resistance                      | T <sub>JA</sub> |  |         | 32  |      | °C/W |  |
|   | T <sub>JC</sub> |  |         | 4.2 |      | °C/W |  |

(6) The ADC section is powered down during CW mode operation.

(7) With VCA\_PD and ADC\_PD pins = high. The ADC\_PD pin is configured for partial power-down (see the *Power-Down Modes* section).

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# **DIGITAL CHARACTERISTICS**

DC specifications refer to the condition where the digital outputs are not switching, but are permanently at a valid logic level '0' or '1'. At  $C_{LOAD} = 5pF^{(1)}$ ,  $I_{OUT} = 3.5mA^{(2)}$ ,  $R_{LOAD} = 100\Omega^{(2)}$ , and no internal termination, unless otherwise noted.

| PARAMETER  | TEST CONDITIONS   | MIN | ТҮР             | MAX | UNIT            |  |
|--|---|-----|-----------------|-----|-----------------|--|
| DIGITAL INPUTS   |   |     |                 |     |                 |  |
| High-level input voltage                               |   | 1.4 |                 | 3.3 | V               |  |
| Low-level input voltage                                |   | 0   |                 | 0.3 | V               |  |
| High-level input current                               |   |     | 10              |     | μΑ              |  |
| Low-level input current <sup>(3)</sup>                 |   |     | -10             |     | μΑ              |  |
| Input capacitance                                      |   |     | 3               |     | pF              |  |
| LVDS OUTPUTS   |   |     |                 |     |                 |  |
| High-level output voltage                              |   |     | 1375            |     | mV              |  |
| Low-level output voltage                               |   |     | 1025            |     | mV              |  |
| Output differential voltage,  V <sub>OD</sub>          |   |     | 350             |     | mV              |  |
| V <sub>OS</sub> output offset voltage <sup>(2)</sup>   | Common-mode voltage of OUTP and OUTM                                  |     | 1200            |     | mV              |  |
| Output capacitance                                     | Output capacitance inside the device,<br>from either output to ground |     | 2               |     | pF              |  |
| FCLKP and FCLKM  |   | 10  | 1x (clock rate) | 50  | MHz             |  |
| LCLKP and LCLKM  |   | 60  | 6x (clock rate) | 300 | MHz             |  |
| CLOCK  |   |     |                 |     |                 |  |
| Clock input rate                                       |   | 10  |                 | 50  | MSPS            |  |
| Clock duty cycle                                       |   |     | 50              |     | %               |  |
| Clock input amplitude, differential<br>(VCLKP – VCLKM) | Sine-wave, ac-coupled   |     | 3               |     | V <sub>PP</sub> |  |
|  | LVPECL, ac-coupled  |     | 1.6             |     | V <sub>PP</sub> |  |
|  | LVDS, ac-coupled  |     | 0.7             |     | V <sub>PP</sub> |  |
| Clock input amplitude, single-ended (VCLKP)            |   |     |                 |     |                 |  |
| High-level input voltage, V <sub>IH</sub>              | CMOS  | 2.2 |                 |     | V               |  |
| Low-level input voltage, V <sub>II</sub>               | CMOS  |     |                 | 0.6 | V               |  |

(1)

 $C_{\text{LOAD}}$  is the effective external single-ended load capacitance between each output pin and ground.  $I_{\text{OUT}}$  refers to the LVDS buffer current setting;  $R_{\text{LOAD}}$  is the differential load resistance between the LVDS output pair. Except pin J3 (INT/EXT), which has an internal pull-up resistor (52k\Omega) to 3.3V. (2) (3)

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# FUNCTIONAL BLOCK DIAGRAM





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#### **PIN CONFIGURATION**

ZCF PACKAGE 135-BGA BOTTOM VIEW

|      | R | OUT4M     | OUT3M     | OUT2M |        |              | OUT5M | OUT6M                |            |               |
|------|---|-----------|-----------|-------|--------|--------------|-------|----------------------|------------|---------------|
|      | Ρ | OUT4P     | OUT3P     |       |        |              | OUT5P |                      |            |               |
|      | N |           |           |       |        |              |       |                      |            |               |
|      | М |           | DNC<br>() | AVSS1 | AVSS1  | AVSS1        | AVSS1 | AVSS1                | DNC        | DNC           |
|      | L |           | AVDD1     | AVSS1 | AVSS1  | AVSS1        | AVSS1 | AVSS1                | AVDD1      | EN SM         |
|      | к |           | DNC<br>() | AVDD1 |        | AVDD1        | AVDD1 | AVDD1                | см<br>()   | ISET          |
|      | J | AVSS1     | AVDD1     |       | AVSS2  | AVSS2        | AVSS2 | AVDD1                |            |               |
| Rows | н | ADS_PD    | DNC       | DNC   | vca_cs | RST          | SCLK  | <mark>cs</mark><br>◯ | SDATA      | ADS_<br>RESET |
|      | G | CW5       | AVDD2     | VCM   | AVSS2  | AVSS2        | AVSS2 |                      | AVDD2      | CW4           |
|      | F | CW6<br>() | VB1       | VB5   | AVSS2  | AVSS2        | AVSS2 |                      | <b>VB6</b> | сwз<br>()     |
|      | Е | cw7       | AVDD_5V   | VB3   | AVSS2  | AVSS2        | AVSS2 | VB4                  | AVDD_5V    | CW2           |
|      | D | CW8       |           | AVSS2 | AVSS2  |              | AVSS2 | AVSS2                | VB2        | CW1           |
|      | С | cw9       | AVDD2     | AVSS2 | AVSS2  |              | AVSS2 | AVSS2                | AVDD2      | cwo<br>〇      |
|      | в | VBL1      | VBL2      | VBL3  | VBL4   |              |       |                      | VBL6       | VBL5          |
|      | А | IN1<br>() | IN2       | IN3   | IN4    | VCA_PD       | IN8   | <b>IN7</b>           | IN6<br>()  | IN5           |
|      | I | 1         | 2         | 3     | 4      | 5<br>Columns | 6     | 7                    | 8          | 9             |

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|   | CONFIGURATION MAP (TOP VIEW) |         |       |       |        |        |         |         |        |  |
|---|------------------------------|---------|-------|-------|--------|--------|---------|---------|--------|--|
| R | OUT8M                        | OUT7M   | OUT6M | OUT5M | LVSS   | OUT1M  | OUT2M   | OUT3M   | OUT4M  |  |
| Р | OUT8P                        | OUT7P   | OUT6P | OUT5P | LVDD   | OUT1P  | OUT2P   | OUT3P   | OUT4P  |  |
| N | FCLKP                        | FCLKM   | LVDD  | LVDD  | LVSS   | LVSS   | LVSS    | LCLKM   | LCLKP  |  |
| м | DNC                          | DNC     | AVSS1 | AVSS1 | AVSS1  | AVSS1  | AVSS1   | DNC     | DNC    |  |
| L | EN_SM                        | AVDD1   | AVSS1 | AVSS1 | AVSS1  | AVSS1  | AVSS1   | AVDD1   | CLKP   |  |
| к | ISET                         | СМ      | AVDD1 | AVDD1 | AVDD1  | DNC    | AVDD1   | DNC     | CLKM   |  |
| J | REFB                         | REFT    | AVDD1 | AVSS2 | AVSS2  | AVSS2  | INT/EXT | AVDD1   | AVSS1  |  |
| н | ADS_RESET                    | SDATA   | CS    | SCLK  | RST    | VCA_CS | DNC     | DNC     | ADS_PD |  |
| G | CW4                          | AVDD2   | VREFL | AVSS2 | AVSS2  | AVSS2  | VCM     | AVDD2   | CW5    |  |
| F | CW3                          | VB6     | VREFH | AVSS2 | AVSS2  | AVSS2  | VB5     | VB1     | CW6    |  |
| Е | CW2                          | AVDD_5V | VB4   | AVSS2 | AVSS2  | AVSS2  | VB3     | AVDD_5V | CW7    |  |
| D | CW1                          | VB2     | AVSS2 | AVSS2 | DVDD   | AVSS2  | AVSS2   | VCNTL   | CW8    |  |
| с | CW0                          | AVDD2   | AVSS2 | AVSS2 | DVDD   | AVSS2  | AVSS2   | AVDD2   | CW9    |  |
| в | VBL5                         | VBL6    | VBL7  | VBL8  | DNC    | VBL4   | VBL3    | VBL2    | VBL1   |  |
| А | IN5                          | IN6     | IN7   | IN8   | VCA_PD | IN4    | IN3     | IN2     | IN1    |  |
|   | 9                            | 8       | 7     | 6     | 5      | 4      | 3       | 2       | 1      |  |

#### ZCF PACKAGE 135-BGA CONFIGURATION MAP (TOP VIEW)

| Legend: | AVDD1<br>AVDD2<br>DVDD<br>LVDD<br>AVDD_5V | +3.3V; Analog<br>+3.3V; Analog<br>+3.3V; Analog<br>+1.8V; Digital<br>+5V; Analog |
|---------|---|--|
|         | AVSS1<br>AVSS2<br>LVSS                    | Analog Ground<br>Analog Ground<br>Digital Ground                                 |

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#### Table 1. TERMINAL FUNCTIONS

| PIN NO.  | PIN NAME  | FUNCTION     | DESCRIPTION   |
|--|-----------|--------------|---|
| H7   | CS        | Input        | Chip select for serial interface; active low  |
| H1   | ADS_PD    | Input        | Power-down pin for ADS; active high. See the Power-Down Modes section for more information.   |
| H9   | ADS_RESET | Input        | RESET input for ADS; active low   |
| H6   | SCLK      | Input        | Serial clock input for serial interface   |
| H8   | SDATA     | Input        | Serial data input for serial interface  |
| J2, L2, K7, J7,<br>K3, L8, K5, K6  | AVDD1     | POWER        | 3.3V analog supply for ADS  |
| L3, M3, L4, M4,<br>L5, M5, L6, M6,<br>L7, M7, J1   | AVSS1     | GND          | Analog ground for ADS   |
| P5, N6, N7   | LVDD      | POWER        | 1.8V digital supply for ADS   |
| N3, N4, N5, R5   | LVSS      | GND          | Digital ground for ADS  |
| C5, D5   | DVDD      | POWER        | 3.3V digital supply for the VCA; connect to the 3.3V analog supply (AVDD2).                   |
| C2, C8, G2, G8   | AVDD2     | POWER        | 3.3V analog supply for VCA  |
| E2, E8   | AVDD_5V   | POWER        | 5V supply for VCA   |
| C3, D3, C4, D4,<br>E4, F4, G4, E5,<br>F5, G5, C6, D6,<br>E6, F6, G6, C7,<br>D7, J4, J5, J6 | AVSS2     | GND          | Analog ground for VCA   |
| K1   | CLKM      | Input        | Negative clock input for ADS (connect to Ground in single-ended clock mode)                   |
| L1   | CLKP      | Input        | Positive clock input for ADS  |
| K8   | СМ        | Input/Output | 1.5V common-mode I/O for ADS. Becomes input pin in one of the external reference modes.       |
| C9   | CW0       | Output       | CW output 0   |
| D9   | CW1       | Output       | CW output 1   |
| E9   | CW2       | Output       | CW output 2   |
| F9   | CW3       | Output       | CW output 3   |
| G9   | CW4       | Output       | CW output 4   |
| G1   | CW5       | Output       | CW output 5   |
| F1   | CW6       | Output       | CW output 6   |
| E1   | CW7       | Output       | CW output 7   |
| D1   | CW8       | Output       | CW output 8   |
| C1   | CW9       | Output       | CW output 9   |
| L9   | EN_SM     | Input        | Enables access to the VCA register. Active high. Connect permanently to 3.3V (AVDD1).         |
| N8   | FCLKM     | Output       | LVDS frame clock (negative output)  |
| N9   | FCLKP     | Output       | LVDS frame clock (positive output)  |
| A1   | IN1       | Input        | LNA input Channel 1   |
| A2   | IN2       | Input        | LNA input Channel 2   |
| A3   | IN3       | Input        | LNA input Channel 3   |
| A4   | IN4       | Input        | LNA input Channel 4   |
| A9   | IN5       | Input        | LNA input Channel 5   |
| A8   | IN6       | Input        | LNA input Channel 6   |
| A7   | IN7       | Input        | LNA input Channel 7   |
| A6   | IN8       | Input        | LNA input Channel 8   |
| J3   | INT/EXT   | Input        | Internal/ external reference mode select for ADS; internal = high (internal pull-up resistor) |
| K9   | ISET      | Input        | Current bias pin for ADS. Requires $56k\Omega$ to ground.                                     |
| N2   | LCLKM     | Output       | LVDS bit clock (6x); negative output  |
| N1   | LCLKP     | Output       | LVDS bit clock (6x); positive output  |
| R4   | OUT1M     | Output       | LVDS data output (negative), Channel 1  |
| P4   | OUT1P     | Output       | LVDS data output (positive), Channel 1  |
| R3   | OUT2M     | Output       | LVDS data output (negative), Channel 2  |
| P3   | OUT2P     | Output       | LVDS data output (positive), Channel 2  |
| R2   | OUT3M     | Output       | LVDS data output (negative), Channel 3  |



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|  | Table 1. TERMINAL FUNCTIONS (continued) |              |   |  |  |  |  |  |
|--|---|--------------|---|--|--|--|--|--|
| PIN NO.                                  | PIN NAME                                | FUNCTION     | DESCRIPTION   |  |  |  |  |  |
| P2                                       | OUT3P                                   | Output       | LVDS data output (positive), Channel 3  |  |  |  |  |  |
| R1                                       | OUT4M                                   | Output       | LVDS data output (negative), Channel 4  |  |  |  |  |  |
| P1                                       | OUT4P                                   | Output       | LVDS data output (positive), Channel 4  |  |  |  |  |  |
| R6                                       | OUT5M                                   | Output       | LVDS data output (negative), Channel 5  |  |  |  |  |  |
| P6                                       | OUT5P                                   | Output       | LVDS data output (positive), Channel 5  |  |  |  |  |  |
| R7                                       | OUT6M                                   | Output       | LVDS data output (negative), Channel 6  |  |  |  |  |  |
| P7                                       | OUT6P                                   | Output       | LVDS data output (positive), Channel 6  |  |  |  |  |  |
| R8                                       | OUT7M                                   | Output       | LVDS data output (negative), Channel 7  |  |  |  |  |  |
| P8                                       | OUT7P                                   | Output       | LVDS data output (positive), Channel 7  |  |  |  |  |  |
| R9                                       | OUT8M                                   | Output       | LVDS data output (negative), Channel 8  |  |  |  |  |  |
| P9                                       | OUT8P                                   | Output       | LVDS data output (positive), Channel 8  |  |  |  |  |  |
| J9                                       | REFB                                    | Input/Output | 0.5V Negative reference of ADS. Decoupling to ground. Becomes input in external ref mode. |  |  |  |  |  |
| J8                                       | REFT                                    | Input/Output | 2.5V Positive reference of ADS. Decoupling to ground. Becomes input in external ref mode. |  |  |  |  |  |
| H5                                       | RST                                     | Input        | RESET input for VCA. Connect to the VCA_CS pin (H4).                                      |  |  |  |  |  |
| H4                                       | VCA_CS                                  | Output       | Connect to RST-pin (H5)   |  |  |  |  |  |
| F2                                       | VB1                                     | Output       | Internal bias voltage. Bypass to ground with 2.2µF.                                       |  |  |  |  |  |
| D8                                       | VB2                                     | Output       | Internal bias voltage. Bypass to ground with 0.1µF.                                       |  |  |  |  |  |
| E3                                       | VB3                                     | Output       | Internal bias voltage. Bypass to ground with 0.1µF.                                       |  |  |  |  |  |
| E7                                       | VB4                                     | Output       | Internal bias voltage. Bypass to ground with 0.1µF  |  |  |  |  |  |
| F3                                       | VB5                                     | Output       | Internal bias voltage. Bypass to ground with 0.1µF.                                       |  |  |  |  |  |
| F8                                       | VB6                                     | Output       | Internal bias voltage. Bypass to ground with 0.1µF.                                       |  |  |  |  |  |
| B1                                       | VBL1                                    | Input        | Complementary LNA input Channel 1; bypass to ground with 0.1µF.                           |  |  |  |  |  |
| B2                                       | VBL2                                    | Input        | Complementary LNA input Channel 2; bypass to ground with 0.1µF.                           |  |  |  |  |  |
| B3                                       | VBL3                                    | Input        | Complementary LNA input Channel 3; bypass to ground with 0.1µF.                           |  |  |  |  |  |
| B4                                       | VBL4                                    | Input        | Complementary LNA input Channel 4; bypass to ground with 0.1µF.                           |  |  |  |  |  |
| B9                                       | VBL5                                    | Input        | Complementary LNA input Channel 5; bypass to ground with 0.1µF.                           |  |  |  |  |  |
| B8                                       | VBL6                                    | Input        | Complementary LNA input Channel 6; bypass to ground with 0.1µF.                           |  |  |  |  |  |
| B7                                       | VBL7                                    | Input        | Complementary LNA input Channel 7; bypass to ground with 0.1µF.                           |  |  |  |  |  |
| B6                                       | VBL8                                    | Input        | Complementary LNA input Channel 8; bypass to ground with 0.1µF.                           |  |  |  |  |  |
| A5                                       | VCA_PD                                  | Input        | Power-down pin for VCA; low = normal mode, high = power-down mode.                        |  |  |  |  |  |
| G3                                       | VCM                                     | Output       | VCA reference voltage. Bypass to ground with 0.1µF.                                       |  |  |  |  |  |
| D2                                       | VCNTL                                   | Input        | VCA control voltage input   |  |  |  |  |  |
| F7                                       | VREFH                                   | Output       | Clamp reference voltage (2.7V). Bypass to ground with 0.1µF.                              |  |  |  |  |  |
| G7                                       | VREFL                                   | Output       | Clamp reference voltage (2.0V). Bypass to ground with 0.1µF.                              |  |  |  |  |  |
| B5, H2, H3, K2,<br>K4, M1, M2,<br>M8, M9 | DNC                                     |              | Do not connect  |  |  |  |  |  |

# Table 1. TERMINAL FUNCTIONS (continued)

#### LVDS TIMING DIAGRAM



(1) Referenced to ADC Input (internal node) for illustration purposes only.



#### DEFINITION OF SETUP AND HOLD TIMES

# TIMING CHARACTERISTICS<sup>(1)</sup>

|                   |                          |   |     | AFE5805 |     |                      |
|-------------------|--------------------------|---|-----|---------|-----|----------------------|
|                   | PARAMETER                | TEST CONDITIONS   | MIN | TYP     | MAX | UNIT                 |
| t <sub>D(A)</sub> | ADC aperture delay       |   | 1.5 |         | 4.5 | ns                   |
|                   | Aperture delay variation | Channel-to-channel within the same device $(3\sigma)$   |     | ±20     |     | ps                   |
| tj                | Aperture jitter          |   |     | 400     |     | f <sub>S</sub> , rms |
|                   |                          | Time to valid data after coming out of<br>COMPLETE POWER-DOWN mode  |     | 50      |     | μS                   |
| t <sub>WAKE</sub> | Wake-up time             | Time to valid data after coming out of PARTIAL<br>POWER-DOWN mode (with clock continuing to<br>run during power-down) |     | 2       |     | μs                   |
|                   |                          | Time to valid data after stopping and restarting the input clock  |     | 40      |     | μS                   |
|                   | Data latency             |   |     | 12      |     | Clock<br>cycles      |

(1) Timing parameters are ensured by design and characterization; not production tested.



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# LVDS OUTPUT TIMING CHARACTERISTICS<sup>(1)</sup> <sup>(2)</sup>

Typical values are at +25°C, minimum and maximum values over specified temperature range of  $T_{MIN} = 0$ °C to  $T_{MAX} = +70$ °C, sampling frequency = as specified,  $C_{LOAD} = 5$ pF<sup>(3)</sup>,  $I_{OUT} = 3.5$ mA,  $R_{LOAD} = 100\Omega^{(4)}$ , and no internal termination, unless otherwise noted.

|  |   |  | AFE5805 |     |      |        |      |      |        |
|--|---|--|---------|-----|------|--------|------|------|--------|
|  |   |  | 40MSPS  |     |      | 50MSPS |      |      |        |
|  | PARAMETER   | TEST CONDITIONS <sup>(5)</sup>   | MIN     | TYP | MAX  | MIN    | TYP  | MAX  | UNIT   |
| t <sub>SU</sub>                                | Data setup time <sup>(6)</sup>                    | Data valid <sup>(7)</sup> to zero-crossing of LCLKP                                      | 0.67    |     |      | 0.47   |      |      | ns     |
| t <sub>H</sub>                                 | Data hold time <sup>(6)</sup>                     | Zero-crossing of LCLKP to data becoming<br>invalid <sup>(7)</sup>                        | 0.85    |     |      | 0.65   |      |      | ns     |
| t <sub>PROP</sub>                              | Clock propagation delay                           | ADC input clock rising edge cross-over to<br>output clock (FCLKP) rising edge cross-over | 10      | 14  | 16.6 | 10     | 12.5 | 14.1 | ns     |
|  | LVDS bit clock duty cycle                         | Duty cycle of differential clock,<br>(LCLKP – LCLKM)                                     | 45.5    | 50  | 53   | 45     | 50   | 53.5 |        |
|  | Bit clock cycle-to-cycle jitter                   |  |         | 250 |      |        | 250  |      | ps, pp |
|  | Frame clock cycle-to-cycle jitter                 |  |         | 150 |      |        | 150  |      | ps, pp |
| $t_{\rm RISE},t_{\rm FALL}$                    | Data rise time, data fall time                    | Rise time is from -100mV to +100mV<br>Fall time is from +100mV to -100mV                 | 0.09    | 0.2 | 0.4  | 0.09   | 0.2  | 0.4  | ns     |
| t <sub>CLKRISE</sub> ,<br>t <sub>CLKFALL</sub> | Output clock rise time, output<br>clock fall time | Rise time is from -100mV to +100mV<br>Fall time is from +100mV to -100mV                 | 0.09    | 0.2 | 0.4  | 0.09   | 0.2  | 0.4  | ns     |

All characteristics are at the maximum rated speed for each speed grade. (1)

Timing parameters are ensured by design and characterization; not production tested. (2)

CLOAD is the effective external single-ended load capacitance between each output pin and ground. (3)

I<sub>OUT</sub> refers to the LVDS buffer current setting; R<sub>LOAD</sub> is the differential load resistance between the LVDS output pair. (4)

Measurements are done with a transmission line of 100Ω characteristic impedance between the device and the load. (5)

Setup and hold time specifications take into account the effect of jitter on the output data and clock. These specifications also assume (6)that data and clock paths are perfectly matched within the receiver. Any mismatch in these paths within the receiver would appear as reduced timing margin.

(7) Data valid refers to a logic high of +100mV and a logic low of -100mV.

# LVDS OUTPUT TIMING CHARACTERISTICS<sup>(1)</sup> <sup>(2)</sup>

Typical values are at +25°C, minimum and maximum values over specified temperature range of  $T_{MIN} = 0$ °C to  $T_{MAX} = +70$ °C, sampling frequency = as specified,  $C_{LOAD} = 5pF^{(3)}$ ,  $I_{OUT} = 3.5$ mA,  $R_{LOAD} = 100\Omega^{(4)}$ , and no internal termination, unless otherwise noted.

|  |   |   |      |        |      |      | AFE5805 |      |      |        |      |        |  |
|--|---|---|------|--------|------|------|---------|------|------|--------|------|--------|--|
|  |   |   |      | 30MSPS |      |      | 20MSPS  |      |      | 10MSPS |      |        |  |
|  | PARAMETER   | TEST CONDITIONS <sup>(5)</sup>  | MIN  | TYP    | MAX  | MIN  | TYP     | MAX  | MIN  | TYP    | MAX  | UNIT   |  |
| t <sub>SU</sub>                                | Data setup time <sup>(6)</sup>                    | Data valid <sup>(7)</sup> to zero-crossing of LCLKP   | 0.8  |        |      | 1.5  |         |      | 3.7  |        |      | ns     |  |
| t <sub>H</sub>                                 | Data hold time <sup>(6)</sup>                     | Zero-crossing of LCLKP to data<br>becoming invalid <sup>(7)</sup>                           | 1.2  |        |      | 1.9  |         |      | 3.9  |        |      | ns     |  |
| t <sub>PROP</sub>                              | Clock propagation delay                           | ADC input clock rising edge<br>cross-over to output clock (FCLKP)<br>rising edge cross-over | 9.5  | 13.5   | 17.3 | 9.5  | 14.5    | 17.3 | 10   | 14.7   | 17.1 | ns     |  |
|  | LVDS bit clock duty cycle                         | Duty cycle of differential clock,<br>(LCLKP – LCLKM)  | 46.5 | 50     | 52   | 48   | 50      | 51   | 49   | 50     | 51   |        |  |
|  | Bit clock cycle-to-cycle<br>jitter                |   |      | 250    |      |      | 250     |      |      | 750    |      | ps, pp |  |
|  | Frame clock cycle-to-cycle<br>jitter              |   |      | 150    |      |      | 150     |      |      | 500    |      | ps, pp |  |
| t <sub>RISE</sub> ,<br>t <sub>FALL</sub>       | Data rise time, data fall time                    | Rise time is from -100mV to +100mV<br>Fall time is from +100mV to -100mV                    | 0.09 | 0.2    | 0.4  | 0.09 | 0.2     | 0.4  | 0.09 | 0.2    | 0.4  | ns     |  |
| t <sub>CLKRISE</sub> ,<br>t <sub>CLKFALL</sub> | Output clock rise time,<br>output clock fall time | Rise time is from -100mV to +100mV<br>Fall time is from +100mV to -100mV                    | 0.09 | 0.2    | 0.4  | 0.09 | 0.2     | 0.4  | 0.09 | 0.2    | 0.4  | ns     |  |

All characteristics are at the speeds other than the maximum rated speed for each speed grade.

Timing parameters are ensured by design and characterization; not production tested. (2)

CLOAD is the effective external single-ended load capacitance between each output pin and ground. (3)

(4)

 $I_{OUT}$  refers to the LVDS buffer current setting;  $R_{LOAD}$  is the differential load resistance between the LVDS output pair. Measurements are done with a transmission line of 100 $\Omega$  characteristic impedance between the device and the load. (5)

(6)Setup and hold time specifications take into account the effect of jitter on the output data and clock. These specifications also assume that data and clock paths are perfectly matched within the receiver. Any mismatch in these paths within the receiver would appear as reduced timing margin.

Data valid refers to a logic high of +100mV and a logic low of -100mV. (7)

Channel



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AVDD\_5V = 5.0V, AVDD1 = AVDD2 = DVDD = 3.3V, LVDD = 1.8V, single-ended input into LNA, ac-coupled with  $0.1\mu$ F,  $V_{CNTL} = 1.0V$ ,  $f_{IN} = 5$ MHz, clamp disabled, LPF = 15MHz, clock = 40MSPS, 50% duty cycle, internal reference mode, ISET = 56k $\Omega$ , and LVDS buffer setting = 3.5mA, at ambient temperature  $T_A = +25^{\circ}$ C, unless otherwise noted.





# Figure 2.



GAIN MATCH AT V<sub>CNTL</sub> = 0.6V





AFE5805

## **TYPICAL CHARACTERISTICS (continued)**

AVDD\_5V = 5.0V, AVDD1 = AVDD2 = DVDD = 3.3V, LVDD = 1.8V, single-ended input into LNA, ac-coupled with  $0.1\mu$ F,  $V_{CNTL} = 1.0V$ ,  $f_{IN} = 5$ MHz, clamp disabled, LPF = 15MHz, clock = 40MSPS, 50% duty cycle, internal reference mode, ISET = 56k $\Omega$ , and LVDS buffer setting = 3.5mA, at ambient temperature  $T_A = +25^{\circ}$ C, unless otherwise noted.





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# **TYPICAL CHARACTERISTICS (continued)**

 $AVDD_5V = 5.0V$ , AVDD1 = AVDD2 = DVDD = 3.3V, LVDD = 1.8V, single-ended input into LNA, ac-coupled with  $0.1\mu$ F,  $V_{CNTL} = 1.0V$ ,  $f_{IN} = 5$ MHz, clamp disabled, LPF = 15MHz, clock = 40MSPS, 50% duty cycle, internal reference mode, ISET = 56k $\Omega$ , and LVDS buffer setting = 3.5mA, at ambient temperature  $T_A = +25^{\circ}$ C, unless otherwise noted.





# OUTPUT-REFERRED NOISE vs FREQUENCY vs Rs



Figure 13.



INPUT-REFERRED NOISE vs FREQUENCY vs Rs









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#### **TYPICAL CHARACTERISTICS (continued)**

AVDD\_5V = 5.0V, AVDD1 = AVDD2 = DVDD = 3.3V, LVDD = 1.8V, single-ended input into LNA, ac-coupled with  $0.1\mu$ F,  $V_{CNTL}$  = 1.0V,  $f_{IN}$  = 5MHz, clamp disabled, LPF = 15MHz, clock = 40MSPS, 50% duty cycle, internal reference mode, ISET = 56k $\Omega$ , and LVDS buffer setting = 3.5mA, at ambient temperature  $T_A$  = +25°C, unless otherwise noted.



Figure 17.



2ND HARMONIC vs V<sub>CNTL</sub> vs FREQUENCY



**CW ACCURACY** 4000 3500 3000 2500 Channel 2000 1500 1000 500 0 14.6 14.8 14.2 14.4 15.0 15.2 15.4 15.6 15.8 16.0 16.2 16.4 16.6 17.0 14.0 16.8 Transconductance (mA/V) Figure 18.

3RD HARMONIC vs V<sub>CNTL</sub> vs FREQUENCY







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# **TYPICAL CHARACTERISTICS (continued)**

 $AVDD_5V = 5.0V$ , AVDD1 = AVDD2 = DVDD = 3.3V, LVDD = 1.8V, single-ended input into LNA, ac-coupled with  $0.1\mu$ F,  $V_{CNTL} = 1.0V$ ,  $f_{IN} = 5$ MHz, clamp disabled, LPF = 15MHz, clock = 40MSPS, 50% duty cycle, internal reference mode, ISET = 56k $\Omega$ , and LVDS buffer setting = 3.5mA, at ambient temperature  $T_A = +25^{\circ}$ C, unless otherwise noted.





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12k

10k

8k

6k

4k

2k

Magnitude (Ω)

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#### **TYPICAL CHARACTERISTICS (continued)**

 $AVDD_5V = 5.0V$ , AVDD1 = AVDD2 = DVDD = 3.3V, LVDD = 1.8V, single-ended input into LNA, ac-coupled with  $0.1\mu$ F,  $V_{CNTL} = 1.0V$ ,  $f_{IN} = 5$ MHz, clamp disabled, LPF = 15MHz, clock = 40MSPS, 50% duty cycle, internal reference mode, ISET = 56k $\Omega$ , and LVDS buffer setting = 3.5mA, at ambient temperature  $T_A = +25^{\circ}$ C, unless otherwise noted.



15MHz LOW-PASS FILTER RESPONSE 0 -2 -4 -6 -8 -10 -12 -14 -16 -18 -20 0 5 10 15 20 25 30 35 Frequency (MHz)



INTERMODULATION DISTORTION (4.99MHz and 5.01MHz)

0

-20

PGA = 30dB

INTERMODULATION DISTORTION (1.99MHz and 2.01MHz)



Figure 31.

V<sub>CNTL</sub> = 1.0V IMD3 = 58.5dB

-6









0 100k 1M 10M 100M Frequency (Hz) Figure 33.

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Magnitude (Z<sub>IN</sub>)

100

80

60

40

20

0

-40

-60

-80

-100

Phase

Phase

\_20 ©



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# **TYPICAL CHARACTERISTICS (continued)**

 $AVDD_5V = 5.0V$ , AVDD1 = AVDD2 = DVDD = 3.3V, LVDD = 1.8V, single-ended input into LNA, ac-coupled with  $0.1\mu$ F,  $V_{CNTL} = 1.0V$ ,  $f_{IN} = 5$ MHz, clamp disabled, LPF = 15MHz, clock = 40MSPS, 50% duty cycle, internal reference mode, ISET = 56k $\Omega$ , and LVDS buffer setting = 3.5mA, at ambient temperature  $T_A = +25^{\circ}$ C, unless otherwise noted.





# SERIAL INTERFACE

The AFE5805 has a set of internal registers that can be accessed through the serial interface formed by pins  $\overline{CS}$  (chip select, active low), SCLK (serial interface clock), and SDATA (serial interface data). When  $\overline{CS}$  is low, the following actions occur:

- Serial shift of bits into the device is enabled
- SDATA (serial data) is latched at every rising edge of SCLK
- SDATA is loaded into the register at every 24th SCLK rising edge

If the word length exceeds a multiple of 24 bits, the excess bits are ignored. Data can be loaded in multiples of 24-bit words within a single active  $\overline{CS}$  pulse. The first eight bits form the register address and the remaining 16 bits form the register data. The interface can work with SCLK frequencies from 20MHz down to very low speeds (a few hertz) and also with a non-50% SCLK duty cycle.

#### **Register Initialization**

After power-up, the internal registers *must* be initialized to the respective default values. Initialization can be done in one of two ways:

- 1. Through a hardware reset, by applying a low-going pulse on the ADS\_RESET pin; or
- 2. Through a software reset; using the serial interface, set the S\_RST bit high. Setting this bit initializes the internal registers to the respective default values and then self-resets the bit low. In this case, the ADS\_RESET pin stays high (inactive).

It is recommended to program the following registers after the initialization stage. The power-supply ripple and clock jitter effects can be minimized.

| ADDRESS | DATA |
|---------|------|
| 01      | 0010 |
| D1      | 0140 |
| DA      | 0001 |
| E1      | 0020 |
| 02      | 0080 |
| 01      | 0000 |

#### Serial Port Interface (SPI) Information





#### SERIAL INTERFACE TIMING



|                |  |     | AFE5805 |     |      |
|----------------|--|-----|---------|-----|------|
| PARAMETER      | DESCRIPTION  | MIN | TYP     | MAX | UNIT |
| t <sub>1</sub> | SCLK period  | 50  |         |     | ns   |
| t <sub>2</sub> | SCLK high time   | 20  |         |     | ns   |
| t <sub>3</sub> | SCLK low time  | 20  |         |     | ns   |
| t <sub>4</sub> | Data setup time  | 5   |         |     | ns   |
| t <sub>5</sub> | Data hold time   | 5   |         |     | ns   |
| t <sub>6</sub> | CS fall to SCLK rise   | 8   |         |     | ns   |
| t <sub>7</sub> | Time between last SCLK rising edge to $\overline{\text{CS}}$ rising edge | 8   |         |     | ns   |

#### Internally-Generated VCA Control Signals



VCA\_SCLK and VCA\_SDATA signals are generated if:

- Registers with address 16, 17, or 18 (Hex) are written into, and
- EN\_SM pin is HIGH

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#### SERIAL REGISTER MAP

# Table 2. SUMMARY OF FUNCTIONS SUPPORTED BY SERIAL INTERFACE<sup>(1)</sup> <sup>(2)</sup> <sup>(3)</sup> <sup>(4)</sup>

| ADDRESS<br>IN HEX | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 | D7 | D6 | D5          | D4 | D3 | D2 | D1 | D0 | NAME                    | DESCRIPTION   | DEFAULT              |
|-------------------|-----|-----|-----|-----|-----|-----|----|----|----|----|-------------|----|----|----|----|----|-------------------------|---|----------------------|
| 00                |     |     |     |     |     |     |    |    |    |    |             |    |    |    |    | Х  | S_RST                   | Self-clearing software RESET.   | Inactive             |
| 03                | 0   | 0   | 0   | 0   | 0   | 0   | 0  | 0  | 0  | 0  | RES_<br>VCA | 0  | 0  | 0  | 0  | 0  |                         |   |                      |
| 16                | х   | х   | х   | х   | х   | х   | х  | х  | х  | х  | х           | х  | х  | х  | 1  | 1  | VCA_SDATA<br><0:15>     | See Table 4 information   | D5 = 1<br>(TGC mode) |
| 17                | х   | х   | х   | х   | х   | х   | х  | х  | х  | х  | х           | х  | х  | х  | х  | х  | VCA_SDATA<br><16:31>    | See Table 4 information   |                      |
| 18                |     |     |     |     |     |     |    |    | х  | х  | х           | х  | х  | х  | х  | х  | VCA_DATA<br><32:39>     | See Table 4 information   |                      |
|                   |     |     |     |     |     |     |    |    |    |    |             |    | х  | х  | х  | х  | PDN_CH<1:4>             | Channel-specific ADC power-down mode.   | Inactive             |
|                   |     |     |     |     |     |     |    |    | х  | х  | х           | х  |    |    |    |    | PDN_CH<8:5>             | Channel-specific ADC<br>power-down mode.  | Inactive             |
| 0F                |     |     |     |     |     |     |    | х  |    |    |             |    |    |    |    |    | PDN_PARTIAL             | Partial power-down mode (fast recovery from power-down).  | Inactive             |
|                   |     |     |     |     |     | 0   | х  |    |    |    |             |    |    |    |    |    | PDN_COMPLETE            | Register mode for complete power-down (slower recovery).  | Inactive             |
|                   |     |     |     |     |     | х   | 0  |    |    |    |             |    |    |    |    |    | PDN_PIN_CFG             | Configures the PD pin for partial power-down mode.  | Complete power-down  |
|                   |     |     |     |     |     |     |    |    |    |    |             |    |    | x  | х  | x  | ILVDS_LCLK<2:0>         | LVDS current drive<br>programmability for LCLKM<br>and LCLKP pins.  | 3.5mA drive          |
| 11                |     |     |     |     |     |     |    |    |    | x  | х           | x  |    |    |    |    | ILVDS_FRAME<br><2:0>    | LVDS current drive<br>programmability for FCLKM<br>and FCLKP pins.  | 3.5mA drive          |
|                   |     |     |     |     |     | х   | x  | x  |    |    |             |    |    |    |    |    | ILVDS_DAT<2:0>          | LVDS current drive<br>programmability for OUTM and<br>OUTP pins.  | 3.5mA drive          |
|                   |     | х   |     |     |     |     |    |    |    |    |             |    |    |    |    |    | EN_LVDS_TERM            | Enables internal termination for LVDS buffers.  | Termination disabled |
| 10                |     | 1   |     |     |     |     |    |    |    |    |             |    |    | х  | х  | х  | TERM_LCLK<2:0>          | Programmable termination for<br>LCLKM and LCLKP buffers.  | Termination disabled |
| 12                |     | 1   |     |     |     |     |    |    |    | х  | х           | х  |    |    |    |    | TERM_FRAME<br><2:0>     | Programmable termination for<br>FCLKM and FCLKP buffers.  | Termination disabled |
|                   |     | 1   |     |     |     | х   | х  | х  |    |    |             |    |    |    |    |    | TERM_DAT<2:0>           | Programmable termination for<br>OUTM and OUTP buffers.  | Termination disabled |
|                   |     |     |     |     |     |     |    |    |    |    |             |    | x  | x  | х  | x  | LFNS_CH<1:4>            | Channel-specific,<br>low-frequency noise<br>suppression mode enable.  | Inactive             |
| 14                |     |     |     |     |     |     |    |    | x  | x  | х           | x  |    |    |    |    | LFNS_CH<8:5>            | Channel-specific,<br>low-frequency noise<br>suppression mode enable.  | Inactive             |
|                   |     |     |     |     |     |     |    |    |    | х  | 0           | 0  |    |    |    |    | EN_RAMP                 | Enables a repeating full-scale ramp pattern on the outputs.   | Inactive             |
|                   |     |     |     |     |     |     |    |    |    | 0  | х           | 0  |    |    |    |    | DUALCUSTOM_<br>PAT      | Enables the mode wherein the<br>output toggles between two<br>defined codes.  | Inactive             |
| 25                |     |     |     |     |     |     |    |    |    | 0  | 0           | x  |    |    |    |    | SINGLE_CUSTOM<br>_PAT   | Enables the mode wherein the<br>output is a constant specified<br>code.   | Inactive             |
|                   |     |     |     |     |     |     |    |    |    |    |             |    |    |    | х  | x  | BITS_CUSTOM1<br><11:10> | 2MSBs for a single custom<br>pattern (and for the first code<br>of the dual custom pattern).<br><11> is the MSB.          | Inactive             |
|                   |     |     |     |     |     |     |    |    |    |    |             |    | х  | х  |    |    | BITS_CUSTOM2<br><11:10> | 2MSBs for the second code of the dual custom pattern.   | Inactive             |
| 26                | x   | x   | x   | x   | x   | x   | x  | x  | x  | x  |             |    |    |    |    |    | BITS_CUSTOM1<br><9:0>   | 10 lower bits for the single<br>custom pattern (and for the<br>first code of the dual custom<br>pattern). <0> is the LSB. | Inactive             |
| 27                | х   | х   | х   | х   | x   | х   | x  | x  | x  | x  |             |    |    |    |    |    | BITS_CUSTOM2<br><9:0>   | 10 lower bits for the second code of the dual custom pattern.   | Inactive             |

The unused bits in each register (identified as blank table cells) must be programmed as '0'.
 X = Register bit referenced by the corresponding name and description (default setting is listed above).

Bits marked as '0' should be forced to 0, and bits marked as '1' should be forced to 1 when the particular register is programmed. (3)

Multiple functions in a register should be programmed in a single write operation. (4)



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# Table 2. SUMMARY OF FUNCTIONS SUPPORTED BY SERIAL INTERFACE (1) (2) (3) (4) (continued)

|                   |     |     |     |     |     |     |    |    |    |    |    |    |    |    |    |    |                | (oonane  | ,   |
|-------------------|-----|-----|-----|-----|-----|-----|----|----|----|----|----|----|----|----|----|----|----------------|--|---|
| ADDRESS<br>IN HEX | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | NAME           | DESCRIPTION  | DEFAULT   |
|                   |     |     |     |     |     |     |    |    |    |    |    |    | Х  | Х  | Х  | Х  | GAIN_CH4<3:0>  | Programmable gain channel 4.   | 0dB gain  |
|                   |     |     |     |     |     |     |    |    | Х  | Х  | Х  | Х  |    |    |    |    | GAIN_CH3<3:0>  | Programmable gain channel 3.   | 0dB gain  |
| 2A                |     |     |     |     | Х   | Х   | Х  | Х  |    |    |    |    |    |    |    |    | GAIN_CH2<3:0>  | Programmable gain channel 2.   | 0dB gain  |
|                   | Х   | Х   | Х   | Х   |     |     |    |    |    |    |    |    |    |    |    |    | GAIN_CH1<3:0>  | Programmable gain channel 1.   | 0dB gain  |
|                   | Х   | Х   | Х   | Х   |     |     |    |    |    |    |    |    |    |    |    |    | GAIN_CH5<3:0>  | Programmable gain channel 5.   | 0dB gain  |
|                   |     |     |     |     | Х   | Х   | Х  | Х  |    |    |    |    |    |    |    |    | GAIN_CH6<3:0>  | Programmable gain channel 6.   | 0dB gain  |
| 2B                |     |     |     |     |     |     |    |    | Х  | Х  | Х  | Х  |    |    |    |    | GAIN_CH7<3:0>  | Programmable gain channel 7.   | 0dB gain  |
|                   |     |     |     |     |     |     |    |    |    |    |    |    | Х  | Х  | Х  | Х  | GAIN_CH8<3:0>  | Programmable gain channel 8.   | 0dB gain  |
|                   | 1   |     |     |     |     |     |    |    | 1  |    |    |    |    |    |    | х  | DIFF_CLK       | Differential clock mode.   | Single-<br>ended clock                                |
|                   | 1   |     |     |     |     |     |    |    | 1  |    |    |    |    | х  |    |    | EN_DCC         | Enables the duty-cycle<br>correction circuit.  | Disabled  |
| 42                | 1   |     |     |     |     |     |    |    | 1  |    |    |    | x  |    |    |    | EXT_REF_VCM    | Drives the external reference mode through the VCM pin.  | External<br>reference<br>drives REF<br>and REFB       |
|                   | 1   |     |     |     |     |     |    |    | 1  | х  | х  |    |    |    |    |    | PHASE_DDR<1:0> | Controls the phase of LCLK output relative to data.  | 90 degrees  |
| 45                |     |     |     |     |     |     |    |    |    |    |    |    |    |    | 0  | Х  | PAT_DESKEW     | Enables deskew pattern mode.   | Inactive  |
| 45                |     |     |     |     |     |     |    |    |    |    |    |    |    |    | Х  | 0  | PAT_SYNC       | Enables sync pattern mode.   | Inactive  |
|                   | 1   |     |     |     |     |     | 1  |    |    |    |    |    |    | х  |    |    | BTC_MODE       | Binary two's complement<br>format for ADC output.  | Straight<br>offset binary                             |
|                   | 1   |     |     |     |     |     | 1  |    |    |    |    |    | х  |    |    |    | MSB_FIRST      | Serialized ADC output comes<br>out MSB-first.  | LSB-first<br>output                                   |
| 46                | 1   |     |     |     |     |     | 1  |    |    |    |    | x  |    |    |    |    | EN_SDR         | Enables SDR output mode<br>(LCLK becomes a 12x input<br>clock).  | DDR output<br>mode                                    |
|                   | 1   |     | 1   |     |     |     | 1  |    |    |    |    | 1  |    |    |    |    | FALL_SDR       | Controls whether the LCLK<br>rising or falling edge comes in<br>the middle of the data window<br>when operating in SDR output<br>mode. | Rising edge<br>of LCLK in<br>middle of<br>data window |

# SUMMARY OF FEATURES

| FEATURES   | DEFAULT            | SELECTION           | POWER IMPACT (Relative to Default)<br>AT f <sub>s</sub> = 50MSPS   |
|--|--------------------|---------------------|--|
| ANALOG FEATURES  |                    |                     |  |
| Internal or external reference<br>(driven on the REFT and REFB pins) | N/A                | Pin                 | Internal reference mode takes approximately 20mW more power on AVDD1   |
| External reference driven on the CM pin                              | Off                | Register 42         | Approximately 8mW less power on AVDD1  |
| Duty cycle correction circuit  | Off                | Register 42         | Approximately 7mW more power on AVDD1  |
| Low-frequency noise suppression                                      | Off                | Register 14         | With zero input to the ADC, low-frequency noise suppression causes digital switching at fs/2, thereby increasing LVDD power by approximately 5.5mW/channel |
| Single-ended or differential clock                                   | Single-ended       | Register 42         | Differential clock mode takes approximately 7mW more power on AVDD1  |
| Power-down mode  | Off                | Pin and register 0F | Refer to the Power-Down Modes section in the Electrical Characteristics table  |
| DIGITAL FEATURES   |                    |                     |  |
| Programmable digital gain (0dB to 12dB)                              | 0dB                | Registers 2A and 2B | No difference  |
| Straight offset or BTC output  | Straight offset    | Register 46         | No difference  |
| LVDS OUTPUT PHYSICAL LAYER   |                    |                     |  |
| LVDS internal termination  | Off                | Register 12         | Approximately 7mW more power on AVDD1  |
| LVDS current programmability   | 3.5mA              | Register 11         | As per LVDS clock and data buffer current setting  |
| LVDS OUTPUT TIMING   |                    |                     |  |
| LSB- or MSB-first output   | LSB-first          | Register 46         | No difference  |
| DDR or SDR output  | DDR                | Register 46         | SDR mode takes approximately 2mW more power on LVDD (at $f_s = 30MSPS$ )   |
| LCLK phase relative to data output                                   | Refer to Figure 43 | Register 42         | No difference  |



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# **DESCRIPTION OF SERIAL REGISTERS**

#### SOFTWARE RESET

| ADDRESS<br>IN HEX | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | NAME  |
|-------------------|-----|-----|-----|-----|-----|-----|----|----|----|----|----|----|----|----|----|----|-------|
| 00                |     |     |     |     |     |     |    |    |    |    |    |    |    |    |    | Х  | S_RST |

Software reset is applied when the RST bit is set to '1'; setting this bit resets all internal registers and self-clears to '0'.

| ADDRESS<br>IN HEX | D15        | D14        | D13        | D12        | D11        | D10        | D9         | D8         | D7         | D6         | D5          | D4         | D3         | D2         | D1                     | D0                     |
|-------------------|------------|------------|------------|------------|------------|------------|------------|------------|------------|------------|-------------|------------|------------|------------|------------------------|------------------------|
| 03                | 0          | 0          | 0          | 0          |            | 0          | 0          | 0          | 0          | 0          | RES_V<br>CA | 0          | 0          | 0          | 0                      | 0                      |
| 16                | VCA<br>D15 | VCA<br>D14 | VCA<br>D13 | VCA<br>D12 | VCA<br>D11 | VCA<br>D10 | VCA<br>D9  | VCA<br>D8  | VCA<br>D7  | VCA<br>D6  | VCA<br>D5   | VCA<br>D4  | VCA<br>D3  | VCA<br>D2  | 1 <sup>(1)</sup><br>D1 | 1 <sup>(1)</sup><br>D0 |
| 17                | VCA<br>D31 | VCA<br>D30 | VCA<br>D29 | VCA<br>D28 | VCA<br>D27 | VCA<br>D26 | VCA<br>D25 | VCA<br>D24 | VCA<br>D23 | VCA<br>D22 | VCA<br>D21  | VCA<br>D20 | VCA<br>D19 | VCA<br>D18 | VCA<br>D17             | VCA<br>D16             |
| 18                |            |            |            |            |            |            |            |            | VCA<br>D39 | VCA<br>D38 | VCA<br>D37  | VCA<br>D36 | VCA<br>D35 | VCA<br>D34 | VCA<br>D33             | VCA<br>D32             |

#### Table 3. VCA Register Information

(1) Bits D0 and D1 of register 16 are forced to '1'.

- VCA\_SCLK and VCA\_SDATA become active only when one of the registers 16, 17, or 18 of the AFE5805 are written into.
- The contents of all three registers (total 40 bits) are written on VCA\_SDATA even if only one of the above registers is written into. This condition is only valid if the content of the register has changed because of the most recent write. Writing contents that are the same as existing contents does not trigger activity on VCA\_SDATA.
- For example, if register 17 is written into after a RESET is applied, then the contents of register 17 as well as the default values of the bits in registers 16 and 18 are written into VCA\_SDATA.
- If register 16 is then written to, then the new contents of register 16, the previously written contents of register 17, and the default contents of register 18 are written into VCA\_SDATA. Note that regardless of what is written into D0 and D1 of register 16, the respective outputs on VCA\_SDATA are always '1'.
- Alternatively, all three registers (16, 17 and 18) can also be written within one write cycle of the serial interface. In that case, there would be 48 consecutive SCLK edges within the same CS active window.
- VCA\_SCLK is generated using an oscillator (running at approximately 6MHz) inside the AFE5805, but the oscillator is gated so that it is active only during the write operation of the 40 VCA bits.
- To ensure the SDATA transfer reliability, a ≥ 1µs gap is recommended between programming two VCA registers consecutively.

#### VCA Reset

- VCA\_CS should be permanently connected to the RST-input.
- When VCA\_CS goes high (either because of an active low pulse on ADS\_RESET for more than 10ns or as a result or setting bit RES\_VCA), the following functions are performed inside the AFE5805:
  - Bits D0 and D1 of register 16 are forced to '1'
  - All other bits in registers 16, 17 and 18 are RESET to the respective default values ('0' for all bits except D5 of register 16 which is set to a default of '1').
  - No activity on signals VCA\_SCLK and VCA\_SDATA.
- If bit RES\_VCA has been set to '1', then the state machine is in the RESET state until RES\_VCA is set to '0'.



### INPUT REGISTER BIT MAPS

| BYTE 1  | BY     | TE 2    | BY      | ГЕ 3    | BYI     | ГЕ 4    | BYTE 5  |         |  |  |
|---------|--------|---------|---------|---------|---------|---------|---------|---------|--|--|
| D0:D7   | D8:D11 | D12:D15 | D16:D19 | D20:D23 | D24:D27 | D28:D31 | D32:D35 | D36:D39 |  |  |
| Control | CH1    | CH2     | СНЗ     | CH4     | CH5     | CH6     | CH7     | CH8     |  |  |

#### Table 4. VCA Register Map

#### Table 5. Byte 1—Control Byte Register Map

| BIT NUMBER | BIT NAME | DESCRIPTION                                      |
|------------|----------|--|
| D0 (LSB)   | 1        | Start bit; this bit is permanently set high = 1  |
| D1         | WR       | Write bit; this bit is permanently set high = 1  |
| D2         | PWR      | 1= Power-down mode enabled.                      |
| D3         | BW       | Low-pass filter bandwidth setting (see Table 10) |
| D4         | CL       | Clamp level setting (see Table 10)               |
| D5         | Mode     | 1 = TGC mode (default) , 0 = CW Doppler mode     |
| D6         | PG0      | LSB of PGA gain control (see Table 11)           |
| D7 (MSB)   | PG1      | MSB of PGA gain control                          |

#### Table 6. Byte 2—First Data Byte

| BIT NUMBER | BIT NAME | DESCRIPTION                      |
|------------|----------|----------------------------------|
| D8 (LSB)   | DB1:1    | Channel 1, LSB of matrix control |
| D9         | DB1:2    | Channel 1, matrix control        |
| D10        | DB1:3    | Channel 1, matrix control        |
| D11        | DB1:4    | Channel 1, MSB of matrix control |
| D12        | DB2:1    | Channel 2, LSB of matrix control |
| D13        | DB2:2    | Channel 2, matrix control        |
| D14        | DB2:3    | Channel 2, matrix control        |
| D15 (MSB)  | DB2:4    | Channel 2, MSB of matrix control |

# Table 7. Byte 3—Second Data Byte

| BIT NUMBER | BIT NAME | DESCRIPTION                      |
|------------|----------|----------------------------------|
| D16 (LSB)  | DB3:1    | Channel 3, LSB of matrix control |
| D17        | DB3:2    | Channel 3, matrix control        |
| D18        | DB3:3    | Channel 3, matrix control        |
| D19        | DB3:4    | Channel 3, MSB of matrix control |
| D20        | DB4:1    | Channel 4, LSB of matrix control |
| D21        | DB4:2    | Channel 4, matrix control        |
| D22        | DB4:3    | Channel 4, matrix control        |
| D23 (MSB)  | DB4:4    | Channel 4, MSB of matrix control |

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#### Table 8. Byte 4—Third Data Byte

| BIT NUMBER | BIT NAME | DESCRIPTION                      |
|------------|----------|----------------------------------|
| D24 (LSB)  | DB5:1    | Channel 5, LSB of matrix control |
| D25        | DB5:2    | Channel 5, matrix control        |
| D26        | DB5:3    | Channel 5, matrix control        |
| D27        | DB5:4    | Channel 5, MSB of matrix control |
| D28        | DB6:1    | Channel 6, LSB of matrix control |
| D29        | DB6:2    | Channel 6, matrix control        |
| D30        | DB6:3    | Channel 6, matrix control        |
| D31 (MSB)  | DB6:4    | Channel 6, MSB of matrix control |

#### Table 9. Byte 5—Fourth Data Byte

| BIT NUMBER | BIT NAME | DESCRIPTION                      |
|------------|----------|----------------------------------|
| D32 (LSB)  | DB7:1    | Channel 7, LSB of matrix control |
| D33        | DB7:2    | Channel 7, matrix control        |
| D34        | DB7:3    | Channel 7, matrix control        |
| D35        | DB7:4    | Channel 7, MSB of matrix control |
| D36        | DB8:1    | Channel 8, LSB of matrix control |
| D37        | DB8:2    | Channel 8, matrix control        |
| D38        | DB8:3    | Channel 8, matrix control        |
| D39 (MSB)  | DB8:4    | Channel 8, MSB of matrix control |

#### Table 10. Clamp Level and LPF Bandwidth Setting

|    |        | FUNCTION   |
|----|--------|--|
| BW | D3 = 0 | Bandwidth set to 15MHz (default)   |
| BW | D3 = 1 | Bandwidth set to 10MHz   |
| CL | D4 = 0 | Clamps the output signal at approximately –1.4dB below the full-scale of 2VPP. |
| CL | D4 = 1 | Clamp transparent (disabled)   |

#### Table 11. PGA Gain Setting

| PG1 (D7) | PG0 (D6) | FUNCTION                        |
|----------|----------|---------------------------------|
| 0        | 0        | Sets PGA gain to 20dB (default) |
| 0        | 1        | Sets PGA gain to 25dB           |
| 1        | 0        | Sets PGA gain to 27dB           |
| 1        | 1        | Sets PGA gain to 30dB           |

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| Table 12. CW Switch Matrix Control for Each Channel |   |   |  |  |  |  |  |  |  |  |  |  |  |
|---|---|---|--|--|--|--|--|--|--|--|--|--|--|
| DBn:3   | DBn:2   | DBn:1 (LSB)   | LNA INPUT CHANNEL n DIRECTED TO                        |  |  |  |  |  |  |  |  |  |  |
| 0   | 0   | 0   | Output CW0   |  |  |  |  |  |  |  |  |  |  |
| 0   | 0   | 1   | Output CW1   |  |  |  |  |  |  |  |  |  |  |
| 0   | 1   | 0   | Output CW2   |  |  |  |  |  |  |  |  |  |  |
| 0   | 1   | 1   | Output CW3   |  |  |  |  |  |  |  |  |  |  |
| 1   | 0   | 0   | Output CW4   |  |  |  |  |  |  |  |  |  |  |
| 1   | 0   | 1   | Output CW5   |  |  |  |  |  |  |  |  |  |  |
| 1   | 1   | 0   | Output CW6   |  |  |  |  |  |  |  |  |  |  |
| 1   | 1   | 1   | Output CW7   |  |  |  |  |  |  |  |  |  |  |
| 0   | 0   | 0   | Output CW8   |  |  |  |  |  |  |  |  |  |  |
| 0   | 0   | 1   | Output CW9   |  |  |  |  |  |  |  |  |  |  |
| 0   | 1   | 0   | Connected to AVDD_5V                                   |  |  |  |  |  |  |  |  |  |  |
| 0   | 1   | 1   | Connected to AVDD_5V                                   |  |  |  |  |  |  |  |  |  |  |
| 1   | 0   | 0   | Connected to AVDD_5V                                   |  |  |  |  |  |  |  |  |  |  |
| 1   | 0   | 1   | Connected to AVDD_5V                                   |  |  |  |  |  |  |  |  |  |  |
| 1   | 1   | 0   | Connected to AVDD_5V                                   |  |  |  |  |  |  |  |  |  |  |
| 1   | 1   | 1   | Connected to AVDD_5V                                   |  |  |  |  |  |  |  |  |  |  |
|   | 0<br>0<br>0<br>1<br>1<br>1<br>1<br>0<br>0<br>0<br>0 | 0         0           0         0           0         1           0         1           1         0           1         0           1         1           1         1           0         0           1         1           0         0           0         0           0         1           0         1           0         1           0         1           0         1           0         1           0         1           0         1 | $\begin{array}{c c c c c c c c c c c c c c c c c c c $ |  |  |  |  |  |  |  |  |  |  |



Figure 42. Basic CW Cross-Point Switch Matrix Configuration



#### POWER-DOWN MODES

| ADDRESS<br>IN HEX | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | NAME         |
|-------------------|-----|-----|-----|-----|-----|-----|----|----|----|----|----|----|----|----|----|----|--------------|
|                   |     |     |     |     |     |     |    |    |    |    |    |    | Х  | Х  | Х  | Х  | PDN_CH<1:4>  |
|                   |     |     |     |     |     |     |    |    | х  | Х  | Х  | Х  |    |    |    |    | PDN_CH<8:5>  |
| 0F                |     |     |     |     |     |     |    | х  |    |    |    |    |    |    |    |    | PDN_PARTIAL  |
|                   |     |     |     |     |     | 0   | Х  |    |    |    |    |    |    |    |    |    | PDN_COMPLETE |
|                   |     |     |     |     |     | Х   | 0  |    |    |    |    |    |    |    |    |    | PDN_PIN_CFG  |

Each of the eight ADC channels within the AFE5805 can be individually powered down. PDN\_CH<N> controls the power-down mode for the ADC channel <N>.

In addition to channel-specific power-down, the AFE5805 also has two global power-down modes: partial power-down mode and complete power-down mode.

In addition to programming the device for either of these two power-down modes (through either the PDN\_PARTIAL or PDN\_COMPLETE bits, respectively), the ADS\_PD pin itself can be configured as either a partial power-down pin or a complete power-down pin control. For example, if PDN\_PIN\_CFG = 0 (default), when the ADS\_PD pin is high, the device enters complete power-down mode. However, if PDN\_PIN\_CFG = 1, when the ADS\_PD pin is high, the device enters partial power-down mode.

The partial power-down mode function allows the AFE5805 to be rapidly placed in a low-power state. In this mode, most amplifiers in the signal path are powered down, while the internal references remain active. This configuration ensures that the external bypass capacitors retain the respective charges, minimizing the wake-up response time. The wake-up response is typically less than  $50\mu$ s, provided that the clock has been running for at least  $50\mu$ s before normal operating mode resumes. The power-down time is instantaneous (less than  $1.0\mu$ s).

In partial power-down mode, the part typically dissipates only 233mW, representing a 76% power reduction compared to the normal operating mode. This function is controlled through the ADS\_PD and VCA\_PD pins, which are designed to interface with 3.3V low-voltage logic. If separate control of the two PD pins is not desired, then both can be tied together. In this case, the ADS\_PD pin should be configured to operate as a partial power-down mode pin [see further information (PDN\_PIN\_CFG) above].

For normal operation the PD pins should be tied to a logic low (0); a high (1) places the AFE5805 into partial power-down mode.

To achieve the lowest power dissipation of only 64mW, the AFE5805 can be placed in complete power-down mode. This mode is controlled through the serial interface by setting Register 16 (bit D2) and Register 0F (bit D9:D10). In complete power-down mode, all circuits (including references) within the AFE5805 are powered-down, and the bypass capacitors then discharge. Consequently, the wake-up time from complete power-down mode depends largely on the time needed to recharge the bypass capacitors. Another factor that affects the wake-up time is the elapsed time that the AFE5805 spends in shutdown mode.

#### LVDS DRIVE PROGRAMMABILITY

| ADDRESS<br>IN HEX | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | NAME             |
|-------------------|-----|-----|-----|-----|-----|-----|----|----|----|----|----|----|----|----|----|----|------------------|
|                   |     |     |     |     |     |     |    |    |    |    |    |    |    | Х  | Х  | Х  | ILVDS_LCLK<2:0>  |
| 11                |     |     |     |     |     |     |    |    |    | Х  | х  | х  |    |    |    |    | ILVDS_FRAME<2:0> |
|                   |     |     |     |     |     | Х   | Х  | Х  |    |    |    |    |    |    |    |    | ILVDS_DAT<2:0>   |

The LVDS drive strength of the bit clock (LCLKP or LCLKM) and the frame clock (FCLKP or FCLKM) can be individually programmed. The LVDS drive strengths of all the data outputs OUTP and OUTM can also be programmed to the same value.

All three drive strengths (bit clock, frame clock, and data) are programmed using sets of three bits. Table 13 details an example of how the drive strength of the bit clock is programmed (the method is similar for the frame clock and data drive strengths).



| ILVDS_LCLK<2> | ILVDS_LCLK<1> | ILVDS_LCLK<0> | LVDS DRIVE STRENGTH FOR LCLKP AND LCLKM |
|---------------|---------------|---------------|---|
| 0             | 0             | 0             | 3.5mA (default)                         |
| 0             | 0             | 1             | 2.5mA                                   |
| 0             | 1             | 0             | 1.5mA                                   |
| 0             | 1             | 1             | 0.5mA                                   |
| 1             | 0             | 0             | 7.5mA                                   |
| 1             | 0             | 1             | 6.5mA                                   |
| 1             | 1             | 0             | 5.5mA                                   |
| 1             | 1             | 1             | 4.5mA                                   |

#### Table 13. Bit Clock Drive Strength<sup>(1)</sup>

(1) Current settings lower than 1.5mA are not recommended.

#### LVDS INTERNAL TERMINATION PROGRAMMING

| ADDRESS<br>IN HEX | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | NAME            |
|-------------------|-----|-----|-----|-----|-----|-----|----|----|----|----|----|----|----|----|----|----|-----------------|
|                   |     | Х   |     |     |     |     |    |    |    |    |    |    |    |    |    |    | EN_LVDS_TERM    |
| 10                |     | 1   |     |     |     |     |    |    |    |    |    |    |    | Х  | Х  | Х  | TERM_LCLK<2:0>  |
| 12                |     | 1   |     |     |     |     |    |    |    | Х  | Х  | Х  |    |    |    |    | TERM_FRAME<2:0> |
|                   |     | 1   |     |     |     | Х   | Х  | Х  |    |    |    |    |    |    |    |    | TERM_DAT<2:0>   |

The LVDS buffers have high-impedance current sources that drive the outputs. When driving traces with characteristic impedances that are not perfectly matched with the termination impedance on the receiver side, there may be reflections back to the LVDS output pins of the AFE5805 that cause degraded signal integrity. By enabling an internal termination (between the positive and negative outputs) for the LVDS buffers, the signal integrity can be significantly improved in such scenarios. To set the internal termination mode, the EN\_LVDS\_TERM bit should be set to '1'. Once this bit is set, the internal termination values for the bit clock, frame clock, and data buffers can be independently programmed using sets of three bits. Table 14 shows an example of how the internal termination of the LVDS buffer driving the bit clock is programmed (the method is similar for the frame clock and data drive strengths). These termination values are only typical values and can vary by several percent across temperature and from device to device.

| Table 14. | <b>Bit Clock Internal</b> | Termination |
|-----------|---------------------------|-------------|
|-----------|---------------------------|-------------|

| TERM_LCLK<2> | TERM_LCLK<1> | TERM_LCLK<0> | INTERNAL TERMINATION BETWEEN<br>LCLKP AND LCLKM IN Ω |
|--------------|--------------|--------------|--|
| 0            | 0            | 0            | None   |
| 0            | 0            | 1            | 260  |
| 0            | 1            | 0            | 150  |
| 0            | 1            | 1            | 94   |
| 1            | 0            | 0            | 125  |
| 1            | 0            | 1            | 80   |
| 1            | 1            | 0            | 66   |
| 1            | 1            | 1            | 55   |



#### LOW-FREQUENCY NOISE SUPPRESSION MODE

| ADDRESS<br>IN HEX | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | NAME         |
|-------------------|-----|-----|-----|-----|-----|-----|----|----|----|----|----|----|----|----|----|----|--------------|
| 14                |     |     |     |     |     |     |    |    |    |    |    |    | Х  | Х  | Х  | х  | LFNS_CH<1:4> |
| 14                |     |     |     |     |     |     |    |    | Х  | Х  | Х  | Х  |    |    |    |    | LFNS_CH<8:5> |

The low-frequency noise suppression mode is especially useful in applications where good noise performance is desired in the frequency band of 0MHz to 1MHz (around dc). Setting this mode shifts the low-frequency noise of the AFE5805 to approximately  $f_S/2$ , thereby moving the noise floor around dc to a much lower value. LFNS\_CH<8:1> enables this mode individually for each channel.

#### LVDS TEST PATTERNS

| ADDRESS<br>IN HEX | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | NAME                |
|-------------------|-----|-----|-----|-----|-----|-----|----|----|----|----|----|----|----|----|----|----|---------------------|
| 25                |     |     |     |     |     |     |    |    |    | Х  | 0  | 0  |    |    |    |    | EN_RAMP             |
|                   |     |     |     |     |     |     |    |    |    | 0  | Х  | 0  |    |    |    |    | DUALCUSTOM_PAT      |
|                   |     |     |     |     |     |     |    |    |    | 0  | 0  | Х  |    |    |    |    | SINGLE_CUSTOM_PAT   |
|                   |     |     |     |     |     |     |    |    |    |    |    |    |    |    | Х  | Х  | BITS_CUSTOM1<11:10> |
|                   |     |     |     |     |     |     |    |    |    |    |    |    | Х  | Х  |    |    | BITS_CUSTOM2<11:10> |
| 26                | Х   | Х   | Х   | Х   | Х   | Х   | Х  | х  | Х  | Х  |    |    |    |    |    |    | BITS_CUSTOM1<9:0>   |
| 27                | Х   | Х   | Х   | Х   | Х   | Х   | Х  | х  | Х  | Х  |    |    |    |    |    |    | BITS_CUSTOM2<9:0>   |
| 45                |     |     |     |     |     |     |    |    |    |    |    |    |    |    | 0  | Х  | PAT_DESKEW          |
| 45                |     |     |     |     |     |     |    |    |    |    |    |    |    |    | Х  | 0  | PAT_SYNC            |

The AFE5805 can output a variety of test patterns on the LVDS outputs. These test patterns replace the normal ADC data output. Setting EN\_RAMP to '1' causes all the channels to output a repeating full-scale ramp pattern. The ramp increments from zero code to full-scale code in steps of 1LSB every clock cycle. After hitting the full-scale code, it returns back to zero code and ramps again.

The device can also be programmed to output a constant code by setting SINGLE\_CUSTOM\_PAT to '1', and programming the desired code in BITS\_CUSTOM1<11:0>. In this mode, BITS\_CUSTOM<11:0> take the place of the 12-bit ADC data at the output, and are controlled by LSB-first and MSB-first modes in the same way as normal ADC data are.

The device may also be made to toggle between two consecutive codes by programming DUAL\_CUSTOM\_PAT to '1'. The two codes are represented by the contents of BITS\_CUSTOM1<11:0> and BITS\_CUSTOM2<11:0>.

In addition to custom patterns, the device may also be made to output two preset patterns:

- 1. **Deskew patten:** Set using PAT\_DESKEW, this mode replaces the 12-bit ADC output D<11:0> with the 010101010101 word.
- 2. Sync pattern: Set using PAT\_SYNC, the normal ADC word is replaced by a fixed 111111000000 word.

Note that only one of the above patterns can be active at any given instant.



# PROGRAMMABLE GAIN

| ADDRESS<br>IN HEX | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | NAME          |
|-------------------|-----|-----|-----|-----|-----|-----|----|----|----|----|----|----|----|----|----|----|---------------|
| 2A                |     |     |     |     |     |     |    |    |    |    |    |    | х  | х  | х  | х  | GAIN_CH4<3:0> |
|                   |     |     |     |     |     |     |    |    | Х  | Х  | Х  | х  |    |    |    |    | GAIN_CH3<3:0> |
|                   |     |     |     |     | Х   | х   | Х  | Х  |    |    |    |    |    |    |    |    | GAIN_CH2<3:0> |
|                   | х   | Х   | Х   | Х   |     |     |    |    |    |    |    |    |    |    |    |    | GAIN_CH1<3:0> |
| 2B                | х   | Х   | Х   | Х   |     |     |    |    |    |    |    |    |    |    |    |    | GAIN_CH5<3:0> |
|                   |     |     |     |     | Х   | х   | Х  | Х  |    |    |    |    |    |    |    |    | GAIN_CH6<3:0> |
|                   |     |     |     |     |     |     |    |    | Х  | Х  | Х  | х  |    |    |    |    | GAIN_CH7<3:0> |
|                   |     |     |     |     |     |     |    |    |    |    |    |    | х  | Х  | Х  | Х  | GAIN_CH8<3:0> |

The AFE5805, through its registers, allows for a digital gain to be programmed for each channel. This programmable gain can be set to achieve the full-scale output code even with a lower analog input swing. The programmable gain not only fills the output code range of the ADC, but also enhances the SNR of the device by using quantization information from some extra internal bits. The programmable gain for each channel can be individually set using a set of four bits, indicated as GAIN\_CHN<3:0> for Channel N. The gain setting is coded in binary from 0dB to 12dB, as shown in Table 15.

| GAIN_CH1<3> | GAIN_CH1<2> | GAIN_CH1<1> | GAIN_CH1<0> | CHANNEL 1 GAIN SETTING |
|-------------|-------------|-------------|-------------|------------------------|
| 0           | 0           | 0           | 0           | 0dB                    |
| 0           | 0           | 0           | 1           | 1dB                    |
| 0           | 0           | 1           | 0           | 2dB                    |
| 0           | 0           | 1           | 1           | 3dB                    |
| 0           | 1           | 0           | 0           | 4dB                    |
| 0           | 1           | 0           | 1           | 5dB                    |
| 0           | 1           | 1           | 0           | 6dB                    |
| 0           | 1           | 1           | 1           | 7dB                    |
| 1           | 0           | 0           | 0           | 8dB                    |
| 1           | 0           | 0           | 1           | 9dB                    |
| 1           | 0           | 1           | 0           | 10dB                   |
| 1           | 0           | 1           | 1           | 11dB                   |
| 1           | 1           | 0           | 0           | 12dB                   |
| 1           | 1           | 0           | 1           | Do not use             |
| 1           | 1           | 1           | 0           | Do not use             |
| 1           | 1           | 1           | 1           | Do not use             |

#### Table 15. Gain Setting for Channel 1



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# CLOCK, REFERENCE, AND DATA OUTPUT MODES

| ADDRESS<br>IN HEX | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | NAME           |
|-------------------|-----|-----|-----|-----|-----|-----|----|----|----|----|----|----|----|----|----|----|----------------|
| 42                | 1   |     |     |     |     |     |    |    | 1  |    |    |    |    |    |    | Х  | DIFF_CLK       |
|                   | 1   |     |     |     |     |     |    |    | 1  |    |    |    |    | Х  |    |    | EN_DCC         |
|                   | 1   |     |     |     |     |     |    |    | 1  |    |    |    | Х  |    |    |    | EXT_REF_VCM    |
|                   | 1   |     |     |     |     |     |    |    | 1  | Х  | Х  |    |    |    |    |    | PHASE_DDR<1:0> |
|                   | 1   |     |     |     |     |     | 1  |    |    |    |    |    |    | Х  |    |    | BTC_MODE       |
| 40                | 1   |     |     |     |     |     | 1  |    |    |    |    |    | Х  |    |    |    | MSB_FIRST      |
| 46                | 1   |     |     |     |     |     | 1  |    |    |    |    | Х  |    |    |    |    | EN_SDR         |
|                   | 1   |     | 1   |     |     |     | 1  |    |    |    |    | 1  |    |    |    |    | FALL_SDR       |

#### **INPUT CLOCK**

The AFE5805 is configured by default to operate with a single-ended input clock; CLKP is driven by a CMOS clock and CLKM is tied to '0'. However, by programming DIFF\_CLK to '1', the device can be made to work with a differential input clock on CLKP and CLKM. Operating with a low-jitter differential clock generally leads to improved SNR performance.

In cases where the duty cycle of the input clock falls outside the 45% to 55% range, it is recommended to enable an internal duty cycle correction circuit. Enable this circuit by setting the EN\_DCC bit to '1'.

#### **EXTERNAL REFERENCE**

The AFE5805 can be made to operate in external reference mode by pulling the INT/EXT pin to '0'. In this mode, the REFT and REFB pins should be driven with voltage levels of 2.5V and 0.5V, respectively, and must have enough drive strength to drive the switched capacitance loading of the reference voltages by each ADC. The advantage of using the external reference mode is that multiple AFE5805 units can be made to operate with the same external reference, thereby improving parameters such as gain matching across devices. However, in applications that do not have an available high drive, differential external reference, the AFE5805 can still be driven with a single external reference voltage on the CM pin. When EXT\_REF\_VCM is set as '1' (and the INT/EXT pin is set to '0'), the CM pin is configured as an input pin, and the voltages on REFT and REFB are generated as shown in Equation 1 and Equation 2.

$$VREFT = 1.5V + \frac{V_{CM}}{1.5V}$$
(1)  
$$VREFB = 1.5V - \frac{V_{CM}}{1.5V}$$
(2)

(2)



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#### **BIT CLOCK PROGRAMMABILITY**

The output interface of the AFE5805 is normally a DDR interface, with the LCLK rising edge and falling edge transitions in the middle of alternate data windows. Figure 43 shows this default phase.



Figure 43. LCLK Default Phase

The phase of LCLK can be programmed relative to the output frame clock and data using bits PHASE\_DDR<1:0>. Figure 44 shows the LCLK phase modes.



Figure 44. LCLK Phase Programmability Modes



In addition to programming the phase of LCLK in the DDR mode, the device can also be made to operate in SDR mode by setting the EN\_SDR bit to '1'. In this mode, the bit clock (LCLK) is output at 12 times the input clock, or twice the rate as in DDR mode. Depending on the state of FALL\_SDR, LCLK may be output in either of the two manners shown in Figure 45. As Figure 45 illustrates, only the LCLK rising (or falling) edge is used to capture the output data in SDR mode.



Figure 45. SDR Interface Modes

The SDR mode does not work well beyond 40MSPS because the LCLK frequency becomes very high.

#### DATA OUTPUT FORMAT MODES

The ADC output, by default, is in straight offset binary mode. Programming the BTC\_MODE bit to '1' inverts the MSB, and the output becomes binary two's complement mode.

Also by default, the first bit of the frame (following the rising edge of FCLKP) is the LSB of the ADC output. Programming the MSB\_FIRST mode inverts the bit order in the word, and the MSB is output as the first bit following the FCLKP rising edge.



#### **RECOMMENDED POWER-UP SEQUENCING AND RESET TIMING**

 $10\mu s < t_1 < 50m s$ ,  $10\mu s < t_2 < 50m s$ ,  $-10m s < t_3 < 10m s$ ,  $t_4 > 10m s$ ,  $t_5 > 100n s$ ,  $t_6 > 100n s$ ,  $t_7 > 10m s$ , and  $t_8 > 100\mu s$ . The AVDDx and LVDD power-on sequence does not matter as long as  $-10m s < t_3 < 10m s$ . Similar considerations apply while shutting down the device.

#### **POWER-DOWN TIMING**



Power-up time shown is based on  $1\mu$ F bypass capacitors on the reference pins.  $t_{WAKE}$  is the time it takes for the device to wake up completely from power-down mode. The AFE5805 has two power-down modes: complete power-down mode and partial power-down mode.

(1)  $t_{WAKE} \le 50\mu s$  for complete power-down mode.  $t_{WAKE} \le 2\mu s$  for partial power-down mode (provided the clock is not shut off during power-down).

(2) The ADS\_PD pins can be configured for partial power-down mode through a register setting.



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## THEORY OF OPERATION

The AFE5805 is an 8-channel, fully integrated analog front-end device controlling the LNA, attenuator, PGA, LPF, and ADC, that implements a number of proprietary circuit design techniques to specifically address the performance demands of medical ultrasound systems. It offers unparalleled low-noise and low-power performance at a high level of integration. For the TGC signal path, each channel consists of a 20dB fixed-gain low-noise amplifier (LNA), a linear-in-dB voltage-controlled attenuator (VCA), and a programmable gain amplifier (PGA), as well as a clamping and low-pass filter stage. Digitally controlled through the logic interface, the PGA gain can be set to four different settings: 20dB, 25dB, 27dB, and 30dB. At its highest setting, the total available gain of the AFE5805 is therefore 50dB. To facilitate the logarithmic time-gain compensation required for ultrasound systems, the VCA is designed to provide a 46dB attenuation range. Here, all channels are simultaneously controlled by an externally-applied control voltage (V<sub>CNTI</sub>) in the range of 0V to 1.2V. While the LNA is designed to be driven from a single-ended source, the internal TGC signal path is designed to be fully differential to maximize dynamic range while also optimizing for low, even-order harmonic distortion.

CW doppler signal processing is facilitated by routing the differential LNA outputs to V/I amplifier stages. The resulting signal currents of each channel then connect to an 8×10 switch matrix that is controlled through the serial interface and a corresponding register. The CW outputs are typically routed to a passive delay line that allows coherent summing (beam forming) of the active channels and additional off-chip signal processing, as shown in Figure 46.

Applications that do not utilize the CW path can simply operate the AFE5805 in TGC mode. In this mode, the CW blocks (V/I amplifiers and switch matrix) remain powered down, and the CW outputs can be left unconnected.



Figure 46. Functional Block Diagram

# LOW-NOISE AMPLIFIER (LNA)

As with many high-gain systems, the front-end amplifier is critical to achieve a certain overall performance level. Using a new proprietary architecture, the LNA of the AFE5805 delivers exceptional low-noise performance, while operating on a very low quiescent current compared to CMOS-based architectures with similar noise performances.

The LNA performs a single-ended input to differential output voltage conversion and is configured for a fixed gain of 20dB (10V/V). The ultralow input-referred noise of only 0.7nV/VHz, along with the linear input range of 250mV<sub>PP</sub>, results in a wide dynamic range that supports the high demands of PW and CW ultrasound imaging modes. Larger input signals can be accepted by the LNA, but distortion performance degrades as input signal levels increase. The LNA input is internally biased to approximately +2.4V; the signal source should be ac-coupled to the LNA input by an adequately-sized capacitor. Internally, the LNA directly drives the VCA, avoiding the typical drawbacks of ac-coupled architectures, such as slow overload recovery.

# VOLTAGE-CONTROLLED ATTENUATOR (VCA)

The VCA is designed to have a linear-in-dB attenuation characteristic; that is, the average gain loss in dB is constant for each equal increment of the control voltage (VCNTL). Figure 47 shows the simplified schematic of this VCA stage.



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The attenuator is essentially a variable voltage divider that consists of the series input resistor (R<sub>S</sub>) and eight identical shunt FETs placed in parallel and controlled by sequentially activated clipping amplifiers (A1 through A8). Each clipping amplifier can be understood as a specialized voltage comparator with a soft transfer characteristic and well-controlled output limit voltage. Reference voltages V1 through V8 are equally spaced over the 0V to 1.2V control voltage range. As the control voltage rises through the input range of each clipping amplifier, the amplifier output rises from 0V (FET completely ON) to VCM  $- V_T$  (FET nearly OFF), where VCM is the common source voltage and  $V_T$  is the threshold voltage of the FET. As each FET approaches its off state and the control voltage continues to rise, the next clipping amplifier/FET combination takes over for the next portion of the piecewise-linear attenuation characteristic.

Thus, low control voltages have most of the FETs turned on, producing maximum signal attenuation. Similarly, high control voltages turn the FETs off, leading to minimal signal attenuation. Therefore, each FET acts to decrease the shunt resistance of the voltage divider formed by  $R_S$  and the parallel FET network.



Figure 47. Voltage-Controlled Attenuator Simplified Schematic



# PROGRAMMABLE POST-GAIN AMPLIFIER (PGA)

Following the VCA is a programmable post-gain amplifier (PGA). Figure 48 shows a simplified schematic of the PGA, including the clamping stage. The gain of this PGA can be configured to four different gain settings: 20dB, 25dB, 27dB, and 30dB, programmable through the serial port; see Table 10.

The PGA structure consists of a differential, programmable-gain voltage-to-current converter stage followed by transimpedance amplifiers to buffer each side of the differential output. Low input noise is also a requirement for the PGA design as a result of the large amount of signal attenuation that can be applied in the preceding VCA stage. At minimum VCA attenuation (used for small input signals), the LNA noise dominates; at maximum VCA attenuation (large input signals), the attenuator and PGA noise dominate.



Figure 48. Post-Gain Amplifier (Simplified Schematic)

# PROGRAMMABLE CLAMPING

To further optimize the overload recovery behavior of a complete TGC channel, the AFE5805 integrates a programmable clamping stage, as shown in Figure 49. This clamping stage precedes the low-pass filter in order to prevent the filter circuit from being driven into overload, the result of which would be an extended recovery time. Programmable through the serial interface, the clamping level can be either set to clamp the signal level to approximately  $1.7V_{PP}$  differential, or be disabled. Disabling the clamp function increases the current consumption on the 3.3V analog supply (AVDD2) by about 3mA for the full device. Note that with the clamp function enabled, the third-harmonic distortion increases.

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### LOW-PASS FILTER

The AFE5805 integrates an anti-aliasing filter in the form of a programmable low-pass filter (LPF) for each channel. The LPF is designed as a differential, active, second-order filter that approximates a Bessel characteristic, with typically 12dB per octave roll-off. Figure 49 shows the simplified schematic of half the differential active low-pass filter. Programmable through the serial interface, the -3dB frequency corner can be set to either 10MHz or 15MHz. The filter bandwidth is set for all channels simultaneously.



Figure 49. Clamping Stage and Low-Pass Filter (Simplified Schematic)

# ANALOG-TO-DIGITAL CONVERSION

The analog-to-digital converter (ADC) of the AFE5805 employs a pipelined converter architecture that consists of a combination of multi-bit and single-bit internal stages. Each stage feeds its data into the digital error correction logic, ensuring excellent differential linearity and no missing codes at the 12-bit level.

The 12 bits given out by each channel are serialized and sent out on a single pair of pins in LVDS format. All eight channels of the AFE5805 operate from a common input clock (CLKP/M). The sampling clocks for each of the eight channels are generated from the input clock using a carefully matched clock buffer tree. The 12x clock required for the serializer is generated internally from CLKP/M using а phase-locked loop (PLL). A 6x and a 1x clock are also output in LVDS format, along with the data, to enable easy data capture. The AFE5805 operates from internally-generated reference voltages that are trimmed to improve the gain matching across devices, and provide the option to operate the



devices without having to externally drive and route reference lines. The nominal values of REFT and REFB are 2.5V and 0.5V, respectively. The references are internally scaled down differentially by a factor of 2.  $V_{CM}$  (the common-mode voltage of REFT and REFB) is also made available externally through a pin, and is nominally 1.5V.

The ADC output goes to a serializer that operates from a 12x clock generated by the PLL. The 12 data bits from each channel are serialized and sent LSB first. In addition to serializing the data, the serializer also generates a 1x clock and a 6x clock. These clocks are generated in the same way the serialized data are generated, so these clocks maintain perfect synchronization with the data. The data and clock outputs of the serializer are buffered externally using LVDS buffers. Using LVDS buffers to transmit data externally has multiple advantages, such as a reduced number of output pins (saving routing space on the board), reduced power consumption, and reduced effects of digital noise coupling to the analog circuit inside the AFE5805.

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# **APPLICATION INFORMATION**

## ANALOG INPUT AND LNA

While the LNA is designed as a fully differential amplifier, it is optimized to perform a single-ended input to differential output conversion. A simplified schematic of an LNA channel is shown in Figure 50. A bias voltage ( $V_B$ ) of +2.4V is internally applied to the LNA inputs through  $8k\Omega$  resistors. In addition, the dedicated signal input (IN pin) includes a pair of back-to-back diodes that provide a coarse input clamping function in case the input signal rises to large levels, exceeding 0.7V<sub>PP</sub>. verv This configuration prevents the LNA from being driven into a severe overload state, which may otherwise cause an extended overload recovery time. The integrated diodes are designed to handle a dc current of up to approximately 5mA. Depending on the application requirements, the system overload characteristics may be improved by adding external Schottky diodes at the LNA input, as shown in Figure 50.

As Figure 50 also shows, the complementary LNA input ( $V_{BL}$  pin) is internally decoupled by a small capacitor. Furthermore, for each input channel, a separate  $V_{BL}$  pin is brought out for external bypassing. This bypassing should be done with a small,  $0.1\mu$ F (typical) ceramic capacitor placed in close proximity to each  $V_{BL}$  pin. Attention should be given to provide a low-noise analog ground for this bypass capacitor. A noisy ground potential may cause noise to be picked up and injected into the signal path, leading to higher noise levels.

The LNA closed-loop architecture is internally compensated for maximum stability without the need of external compensation components (inductors or capacitors). At the same time, the total input capacitance is kept to a minimum with only 16pF. This architecture minimizes any loading of the signal source that may otherwise lead to а frequency-dependent voltage divider. Moreover, the closed-loop design yields very low offsets and offset drift; this consideration is important because the LNA directly drives the subsequent voltage-controlled attenuator.

The LNA of the AFE5805 uses the benefits of a bipolar process technology to achieve an exceptionally low-noise voltage of  $0.7nV/\sqrt{Hz}$ , and a low current noise of only  $3pA/\sqrt{Hz}$ . With these input-referred noise specifications, the AFE5805 achieves very low noise figure numbers over a wide range of source resistances and frequencies (see Figure 16, *Noise Figure vs Frequency vs R<sub>S</sub>* in the Typical Characteristics). The optimal noise power matching is achieved for source impedances of around 200 $\Omega$ . Further details of the AFE5805 input noise performance are shown in the Typical Characteristic graphs.

Table 16. Noise Figure versus Source Resistance(Rs) at 2MHz

| R <sub>S</sub> (Ω) | NOISE FIGURE (dB) |  |  |  |  |
|--------------------|-------------------|--|--|--|--|
| 50                 | 2.6               |  |  |  |  |
| 200                | 1.0               |  |  |  |  |
| 400                | 1.1               |  |  |  |  |
| 1000               | 2.3               |  |  |  |  |





# OVERLOAD RECOVERY

The AFE5805 is designed in particular for ultrasound applications where the front-end device is required to recover very quickly from an overload condition. Such an overload can either be the result of a transmit pulse feed-through or a strong echo, which can cause overload of the LNA, PGA, and ADC. As discussed earlier, the LNA inputs are internally protected by a pair of back-to-back diodes to prevent severe overload of the LNA. Figure 51 illustrates an ultrasound receive channel front-end that includes typical external overload protection elements. Here, four high-voltage switching diodes are configured in a bridge configuration and form the transmit/receive (T/R) switch. During the transmit period, high voltage pulses from the pulser are applied to the transducer elements and the T/R switch isolates the sensitive LNA input from being damaged by the high voltage signal. However, it is common that fast transients up to several volts leak through the T/R switch and potentially overload the receiver. Therefore, an additional pair of clamping diodes is placed between the T/R switch and the LNA input. In order to clamp the over-voltage to small levels, Schottky diodes (such as the BAS40 series by Infineon<sup>®</sup>) are commonly used. For example, clamping to levels of



±0.3V can significantly reduce the overall overload recovery performance. The T/R switch characteristics are largely determined by the biasing current of the diodes, which can be set by adjusting the  $3k\Omega$  resistor values; for example, setting a higher current level may lead to an improved switching characteristic and reduced noise contribution. A typical front-end protection circuitry may add in the order of  $2nV/\sqrt{Hz}$  of noise to the signal path. The increase in noise also depends on the value of the termination resistor (R<sub>T</sub>).

As Figure 51 shows, the front-end circuitry should be capacitively coupled to the LNA signal input (IN). This coupling ensures that the LNA input bias voltage of +2.4V is maintained and decoupled from any other biasing voltage before the LNA.

Within the AFE5805, overload can occur in either the LNA or the PGA. LNA overload can occur as the result of T/R switch feed-through; and the PGA can be driven into an overload condition by a strong echo in the near-field while the signal gain is high. In any case, the AFE5805 is optimized for very short recovery times, as shown in Figure 51.



Figure 51. Typical Input Overload Protection Circuit of an Ultrasound System



## VCA—GAIN CONTROL

The attenuator (VCA) for each of the eight channels of the AFE5805 is controlled by a single-ended control signal input, the V<sub>CNTL</sub> pin. The control voltage range spans from 0V to 1.2V, referenced to ground. This control voltage varies the attenuation of the VCA based on its linear-in-dB characteristic with its maximum attenuation (minimum gain) at V<sub>CNTL</sub> = 0V, and minimum attenuation (maximum gain) at V<sub>CNTL</sub> = 1.2V. Table 17 shows the nominal gains for each of the four PGA gain settings. The total gain range is typically 46dB and remains constant, independent of the PGA selected; the *Max Gain* column reflects the absolute gain of the full signal path comprised of the fixed LNA gain of 20dB and the programmable PGA gain.

#### Table 17. Nominal Gain Control Ranges for Each of the Four PGA Gain Settings

| PGA GAIN | MIN GAIN AT<br>V <sub>CNTL</sub> = 0V | MAX GAIN AT<br>V <sub>CNTL</sub> = 1.2V |
|----------|---------------------------------------|---|
| 20dB     | -4.5dB                                | 41.5dB                                  |
| 25dB     | –0.5dB                                | 45.5dB                                  |
| 27dB     | 1.5dB                                 | 47.5dB                                  |
| 30dB     | 3.5dB                                 | 49.5dB                                  |

As previously discussed, the VCA architecture uses eight attenuator segments that are equally spaced in order to approximate the linear-in-dB gain-control slope. This approximation results in a monotonic slope; gain ripple is typically less than ±0.5dB.

The AFE5805 gain-control input has a -3dB bandwidth of approximately 1.5MHz. This wide bandwidth, although useful in many applications, can allow high-frequency noise to modulate the gain control input. In practice, this modulation can easily be avoided by additional external filtering (R<sub>F</sub> and C<sub>F</sub>) of the control input, as Figure 52 shows. Stepping the control voltage from 0V to 1.2V, the gain control response time is typically less than 500ns to settle within 10% of the final signal level of  $1V_{PP}$  (–6dBFS) output.

The control voltage input (VCNTL pin) represents a high-impedance input. Multiple AFE5805 devices can be connected in parallel with no significant loading effects using the VCNTL pin of each device. Note that when the  $V_{CNTL}$  pin is left unconnected, it floats up to a potential of about +3.7V. For any voltage level above 1.2V and up to 5.0V, the VCA continues to operate at its minimum attenuation level; however, it is recommended to limit the voltage to approximately 1.5V or less.

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When the AFE5805 operates in CW mode, the attenuator stage remains connected to the LNA outputs. Therefore, it is recommended to set the  $V_{CNTL}$  voltage to +1.2V in order to minimize the internal loading of the LNA outputs. Small improvements in reduced power dissipation and improved distortion performance may also be realized.



Figure 52. External Filtering of the V<sub>CNTL</sub> Input

# CW DOPPLER PROCESSING

The AFE5805 integrates many of the elements necessary to allow for the implementation of a CW doppler processing circuit, such as a V/I converter for each channel and a cross-point switch matrix with an 8-input into 10-output (8×10) configuration.

In order to switch the AFE5805 from the default TGC mode operation into CW mode, bit D5 of the VCA control register must be updated to low ('0'); see Table 5. This setting also enables access to all other that determine the switch registers matrix configuration (see the Input Register Bit Map tables). In order to process CW signals, the LNA internally feeds into a differential V/I amplifier stage. The transconductance of the V/I amplifier is typically 15.6mA/V with a 100mV<sub>PP</sub> input signal. For proper operation, the CW outputs must be connected to an external bias voltage of +2.5V. Each CW output is designed to sink a small dc current of 0.9mA, and can deliver a signal current of up to  $2.9 \text{mA}_{PP}$ .



The resulting signal current then passes through the  $8 \times 10$  switch matrix. Depending on the programmed configuration of the switch matrix, any V/I amplifier current output can be connected to any of 10 CW outputs. This design is a simple current-summing circuit such that each CW output can represent the sum of any or all of the channel currents. The CW outputs are typically routed to a passive LC delay line, allowing coherent summing of the signals.

After summing, the CW signal path further consists of a high dynamic range mixer for down-conversion to I/Q base-band signals. The I/Q signals are then band-limited (that is, low-frequency contents are removed) in a filter stage that precedes a pair of high-resolution, low sample rate ADCs.



Figure 53. Conceptual CW Doppler Signal Path Using Current Summing and a Passive Delay Line for Beamforming



# **CLOCK INPUT**

The eight channels on the device operate from a single clock input. To ensure that the aperture delay and jitter are the same for all channels, the AFE5805 uses a clock tree network to generate individual sampling clocks to each channel. The clock paths for all the channels are matched from the source point to the sampling circuit. This architecture ensures that the performance and timing for all channels are identical. The use of the clock tree for matching introduces an aperture delay that is defined as the delay between the rising edge of FCLK and the actual instant of sampling. The aperture delays for all the channels are matched to the best possible extent. A mismatch of  $\pm 20$  ps ( $\pm 3\sigma$ ) could exist between the aperture instants of the eight ADCs within the same chip. However, the aperture delays of ADCs across two different chips can be several hundred picoseconds apart.

The AFE5805 can operate either in CMOS single-ended clock mode (default is DIFF\_CLK = 0) or differential clock mode (SINE, LVPECL, or LVDS). In the single-ended clock mode, CLKM must be forced to  $0V_{DC}$ , and the single-ended CMOS applied on the CLKP pin. Figure 54 shows this operation.



## Figure 54. Single-Ended Clock Driving Circuit (DIFF\_CLK = 0)

When configured for the differential clock mode (register bit DIFF\_CLK = 1) the AFE5805 clock inputs can be driven differentially (SINE, LVPECL, or LVDS) with little or no difference in performance between them, or with a single-ended (LVCMOS). The common-mode voltage of the clock inputs is set to  $V_{CM}$  using internal 5k $\Omega$  resistors, as shown in This method allows Figure 55. usina transformer-coupled drive circuits for a sine wave clock or ac-coupling for LVPECL and LVDS clock sources, as shown in Figure 56 and Figure 57. When operating in the differential clock mode, the single-ended CMOS clock can be ac-coupled to the CLKP input, with CLKM connected to ground with a 0.1µF capacitor, as Figure 57 shows.

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## Figure 56. Differential Clock Driving Circuit (DIFF\_CLK = 1)



Figure 57. Single-Ended Clock Driving Circuit When DIFF\_CLK = 1

For best performance, the clock inputs must be driven differentially, reducing susceptibility to common-mode noise. For high input frequency sampling, it is recommended to use a clock source with very low jitter. Bandpass filtering of the clock source can help reduce the effect of jitter. If the duty cycle deviates from 50% by more than 2% or 3%, it is recommended to enable the DCC through register bit EN\_DCC.

# **REFERENCE CIRCUIT**

The digital beam-forming algorithm in an ultrasound system relies on gain matching across all receiver channels. A typical system would have about 12 octal AFEs on the board. In such a case, it is critical to ensure that the gain is matched, essentially requiring the reference voltages seen by all the AFEs to be the same. Matching references within the eight channels of a chip is done by using a single internal reference voltage buffer. Trimming the reference voltages on each chip during production ensures that the reference voltages are well-matched across different chips.

All bias currents required for the internal operation of the device are set using an external resistor to ground at the ISET pin. Using a 56k $\Omega$  resistor on ISET generates an internal reference current of 20 $\mu$ A. This current is mirrored internally to generate the bias current for the internal blocks. Using a larger external resistor at ISET reduces the reference bias current and thereby scales down the device operating power. However, it is recommended that the external resistor be within 10% of the specified value of 56k $\Omega$  so that the internal bias margins for the various blocks are proper.

Buffering the internal bandgap voltage also generates the common-mode voltage  $V_{CM}$ , which is set to the midlevel of REFT and REFB. It is meant as a reference voltage to derive the input common-mode if the input is directly coupled. It can also be used to derive the reference common-mode voltage in the external reference mode. Figure 58 shows the suggested decoupling for the reference pins.



The device also supports the use of external reference voltages. There are two methods to force the references externally. The first method involves pulling INT/EXT low and forcing externally REFT and REFB to 2.5V and 0.5V nominally, respectively. In this mode, the internal reference buffer goes to a 3-state output. The external reference driving circuit should be designed to provide the required switching current for the eight ADCs inside the AFE5805. It should be noted that in this mode, CM and ISET continue to be generated from the internal bandgap voltage, as in the internal reference mode. It is therefore important to ensure that the common-mode voltage of the externally-forced reference voltages matches to within 50mV of V<sub>CM</sub>.

The second method of forcing the reference voltages externally can be accessed by pulling INT/EXT low, and programming the serial interface to drive the external reference mode through the CM pin (register bit called EXT\_REF\_VCM). In this mode, CM becomes configured as an input pin that can be driven from external circuitry. The internal reference buffers driving REFT and REFB are active in this mode. Forcing 1.5V on the CM pin in the mode results in REFT and REFB coming to 2.5V and 0.5V, respectively. In general, the voltages on REFT and REFB in this mode are given by Equation 3 and Equation 4:

$$VREFT = 1.5V + \frac{V_{CM}}{1.5V}$$
(3)

VREFB = 
$$1.5V - \frac{V_{CM}}{1.5V}$$
 (4)

The state of the reference voltage internal buffers during\_various combinations of the ADS\_PD, INT/EXT, and EXT\_REF\_VCM register bits is described in Table 18.



Figure 58. Suggested Decoupling on the Reference Pins

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|                   |                       |      | •       |                     |                              | _          |                     |            |  |
|-------------------|-----------------------|------|---------|---------------------|------------------------------|------------|---------------------|------------|--|
| PIN, REGISTER BIT | INTERNAL BUFFER STATE |      |         |                     |                              |            |                     |            |  |
| ADS_PD pin        | 0                     | 0    | 1       | 1                   | 0                            | 0          | 1                   | 1          |  |
| INT/EXT pin       | 0                     | 1    | 0       | 1                   | 0                            | 1          | 0                   | 1          |  |
| EXT_REF_VCM       | 0                     | 0    | 0       | 0                   | 1                            | 1          | 1                   | 1          |  |
| REFT buffer       | 3-state               | 2.5V | 3-state | 2.5V <sup>(1)</sup> | 1.5V + V <sub>CM</sub> /1.5V | Do not use | 2.5V <sup>(1)</sup> | Do not use |  |
| REFB buffer       | 3-state               | 0.5V | 3-state | 0.5V <sup>(1)</sup> | 1.5V – V <sub>CM</sub> /1.5V | Do not use | 0.5V <sup>(1)</sup> | Do not use |  |
| CM pin            | 1.5V                  | 1.5V | 1.5V    | 1.5V                | Force                        | Do not use | Force               | Do not use |  |

Table 18. State of Reference Voltages for Various Combinations of ADS\_PD and INT/EXT

(1) Weakly forced with reduced strength.

## POWER SUPPLIES

The AFE5805 operates on three supply rails: a digital 1.8V supply, and the 3.3V and 5V analog supplies. At initial power-up, the part is operational in TGC mode, with the registers in the respective default configurations (see Table 2).

In TGC mode, only the VCA (attenuator) draws a low current (typically 8mA) from the 5V supply. Switching into the CW mode, the internal V/I-amplifiers are then powered from the 5V rails as well, raising the operating current on the 5V rail. At the same time, the post-gain amplifiers (PGA) are being powered down, thereby reducing the current consumption on the 3.3V rail (refer to the Electrical Characteristics table for details on TGC mode and CW mode current consumption).

All analog supply rails for the AFE5805 should be low noise, including the 3.3V digital supply DVDD that connects to the internal logic blocks of the VCA within the AFE5805. It is recommended to tie the DVDD pins to the same 3.3V analog supply as the AVDD1/2 pins, rather than a different 3.3V rail that may also provide power to other logic device in the system. Transients and noise generated by those devices can couple into the AFE5805 and degrade overall device performance.

# CLOCK JITTER, POWER NOISE, SNR, AND LVDS TIMING

As explained in application note SLYT075, ADC clock jitter can degrade ADC performance. Therefore, it is always preferred to use a low jitter clock to drive the AFE5805. To ensure the performance of the AFE5805, a clock with a jitter of 1ps RMS or better is expected. However, it might not be always possible to use this clock configuration for practical reasons. With a higher clock jitter, the SNR of the AFE5805 may be degraded as well as the LVDS timing stability. In addition, clean and stable power supplies are always preferred to maximize device SNR performance and ensure LVDS timing stability. Poor RMS jitter (> 100ps), combined with inadequate power-supply design (for example, supply voltage drops and ripple increases), can affect LVDS timing. As a result, occasional glitches might be observed on the AFE5805 outputs. If this phenomenon is observed, or if clock jitter and LVDD noise are concerns in the overall system, the registers described in Table 19 can be written as part of the initialization sequence in order to stabilize LVDS clock timing and SNR performance.

 Table 19. Address and Data in Hexadecimal

| ADDRESS | DATA  |
|---------|-------|
| 01      | 0010h |
| D1      | 0140h |
| DA      | 0001h |
| E1      | 0020h |
| 02      | 0080h |
| 01      | 0000h |

Writing to these registers has the following additional effects:

- a. Total chip power increases by approximately 8mW—this includes a current increase of about 1.9mA on AVDD1 and about 1.1mA on LVDD.
- b. With reference to the LVDS Timing Diagram and the Definition of Setup and Hold Times, LCLKP/LCLKM shift by about 100ps to the left relative to CLK and OUTP/OUTM. This shift causes the data setup time to reduce by 100ps and the data hold time to increase by 100ps.
- c. The clock propagation delay (t<sub>PROP</sub>) is reduced by approximately 2ns. The typical and minimum values for this specification are reduced by 2ns, and the maximum value is reduced by 1.5ns.

Power-supply noise usually can be minimized if grounding, bypassing, and printed circuit board (PCB) layout are well managed. Some guidelines can be found in the *Grounding and Bypassing* and *Board Layout* sections.

## **GROUNDING AND BYPASSING**

The AFE5805 distinguishes between three different grounds: AVSS1 and AVSS2 (analog grounds), and LVSS (digital ground). In most cases, it should be adequate to lay out the printed circuit board (PCB) to use a single ground plane for the AFE5805. Care should be taken that this ground plane is properly partitioned between various sections within the system to minimize interactions between analog and digital circuitry. Alternatively, the digital (LVDS) supply set consisting of the LVDD and LVSS pins can be placed on separate power and ground planes. For this configuration, the AVSS and LVSS grounds should be tied together at the power connector in a star layout.

All bypassing and power supplies for the AFE5805 should be referenced to this analog ground plane. All supply pins should be bypassed with 0.1µF ceramic chip capacitors (size 0603 or smaller). In order to minimize the lead and trace inductance, the capacitors should be located as close to the supply pins as possible. Where double-sided component mounting is allowed, these capacitors are best placed directly under the package. In addition, larger bipolar decoupling capacitors (2.2µF to 10µF, effective at lower frequencies) may also be used on the main supply pins. These components can be placed on the PCB in proximity (< 0.5in or 12.7mm) to the AFE5805 itself.

The AFE5805 internally generates a number of reference voltages, such as the bias voltages (VB1 through VB6). Note that in order to achieve optimal low-noise performance, the VB1 pin must be bypassed with a capacitor value of at least 1µF; the recommended value for this bypass capacitor is 2.2µF. All other designed reference pins can be bypassed with smaller capacitor values, typically 0.1µF. For best results choose low-inductance ceramic chip capacitors (size 402) and place them as close as possible to the device pins as possible.

High-speed mixed signal devices are sensitive to various types of noise coupling. One primary source of noise is the switching noise from the serializer and the output buffer/drivers. For the AFE5805, care has been taken to ensure that the interaction between the analog and digital supplies within the device is kept to a minimal amount. The extent of noise coupled and transmitted from the digital and analog sections depends on the effective inductances of each of the supply and ground connections. Smaller effective inductance of the supply and ground pins leads to improved noise suppression. For this reason, multiple pins are used to connect each supply and ground sets. It is important to maintain low inductance properties throughout the design of the PCB layout by use of proper planes and layer thickness.

## **BOARD LAYOUT**

Proper grounding and bypassing, short lead length, and the use of ground and power-supply planes are particularly important for high-frequency designs. performance Achieving optimum with high-performance device such as the AFE5805 requires careful attention to the PCB layout to minimize the effects of board parasitics and optimize component placement. A multilayer PCB usually ensures best results and allows convenient component placement.

In order to maintain proper LVDS timing, all LVDS traces should follow a controlled impedance design (for example,  $100\Omega$  differential). In addition, all LVDS trace lengths should be equal and symmetrical; it is recommended to keep trace length variations less than 150mil (0.150in or 3.81mm).

Additional details on PCB layout techniques can be found in the Texas Instruments Application Report MicroStar BGA Packaging Reference Guide (SSYZ015B), which can be downloaded from the TI web site (www.ti.com).



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## **REVISION HISTORY**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

# 

### Changes from Revision B (July, 2008) to Revision C

| • | Corrected V <sub>CM</sub> subscript for common-mode voltage (internal) and V <sub>CM</sub> output current     | 4  |
|---|---|----|
| • | Changed AVDD2 to AVDD1 in description of pin L9   | 10 |
| • | Added statement about register initialization to Register Initialization section                              | 21 |
| • | Changed bit D7 for address 42; added values of '1' for all four functions                                     | 24 |
| • | Changed VCM pin to CM pin   | 24 |
| • | Revised External Reference section, Equation 1 and Equation 2 to reflect CM pin instead of VCM pin            | 33 |
| • | Corrected second paragraph of Analog-to-Digital Conversion section to change VCM to CM                        | 40 |
| • | Changed total input capacitance description from 30pF to 16pF   | 41 |
| • | Changed VCM to CM   | 45 |
| • | Changed common-mode voltage VCM to V <sub>CM</sub> and related references to CM pin, including Equation 3 and |    |
|   | Equation 4  | 46 |
| • | Changed VCM to V <sub>CM</sub>  | 47 |
| • | Added CLOCK JITTER, POWER NOISE, SNR, AND LVDS TIMING, Clock Jitter, Power Noise, SNR, and LVDS<br>Timing     |    |
|   | ······ 5·····   |    |

## **PACKAGING INFORMATION**

| Orderable Device | Status <sup>(1)</sup> | Package<br>Type | Package<br>Drawing | Pins F | Package<br>Qty | Eco Plan <sup>(2)</sup>    | Lead/Ball Finish | MSL Peak Temp <sup>(3)</sup> |
|------------------|-----------------------|-----------------|--------------------|--------|----------------|----------------------------|------------------|------------------------------|
| AFE5805ZCF       | ACTIVE                | BGA             | ZCF                | 135    | 160            | Green (RoHS &<br>no Sb/Br) | SNAGCU           | Level-3-260C-168 HR          |

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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ZCF (R-PBGA-N135)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994 .

- B. This drawing is subject to change without notice.
- C. This is a lead-free solder ball design.



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